

Center of ultrasonic technologies

**THEORETICAL FOUNDATIONS OF
THE POSSIBILITY AND
SENSITIVITY OF MEDIA CONTROL
ACCORDING TO THE
PARAMETERS OF
PIEZOELECTRIC SYSTEMS**

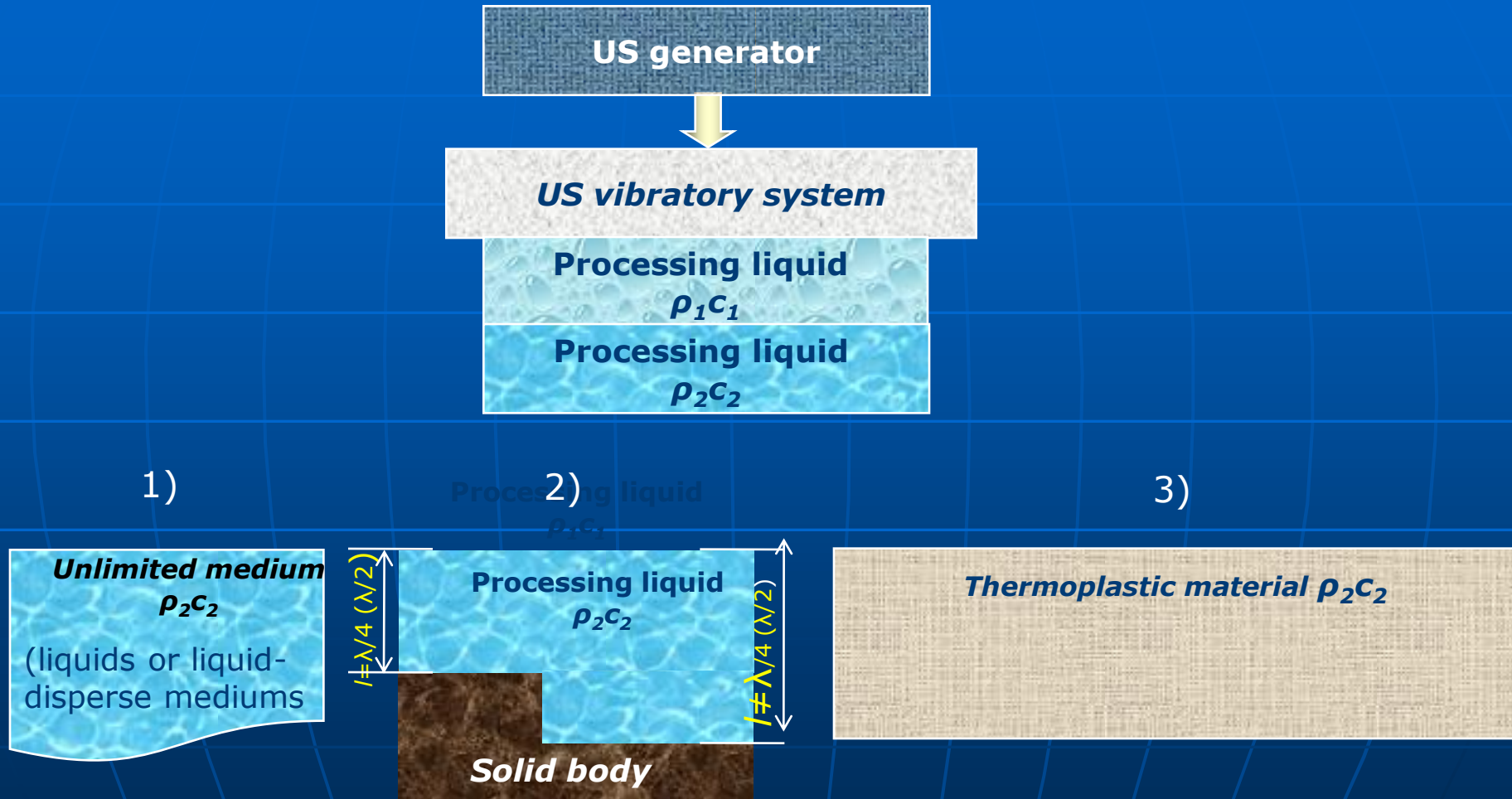
Khmelev Vladimir Nikolaevich



Doctor of Technical Sciences, Professor, Honored Inventor of the Russian Federation, Senior Member IEEE. Laureate of the Russian Government Award in the field of science and technology, author of more than 900 scientific publications (including more than 100 patents, more than 20 monographs and textbooks), Deputy Director for Scientific Work of the Biysk Technological Institute of the Altai State Technical University.

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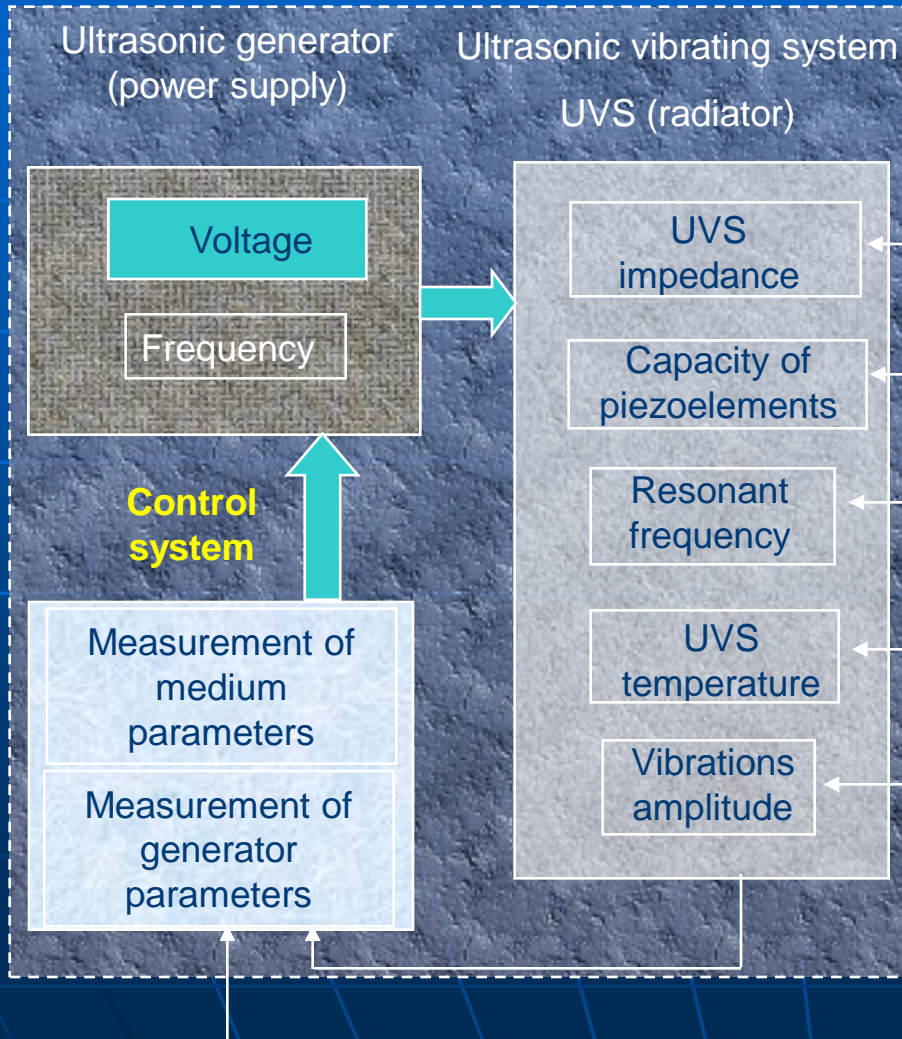
Features of ultrasonic exposure



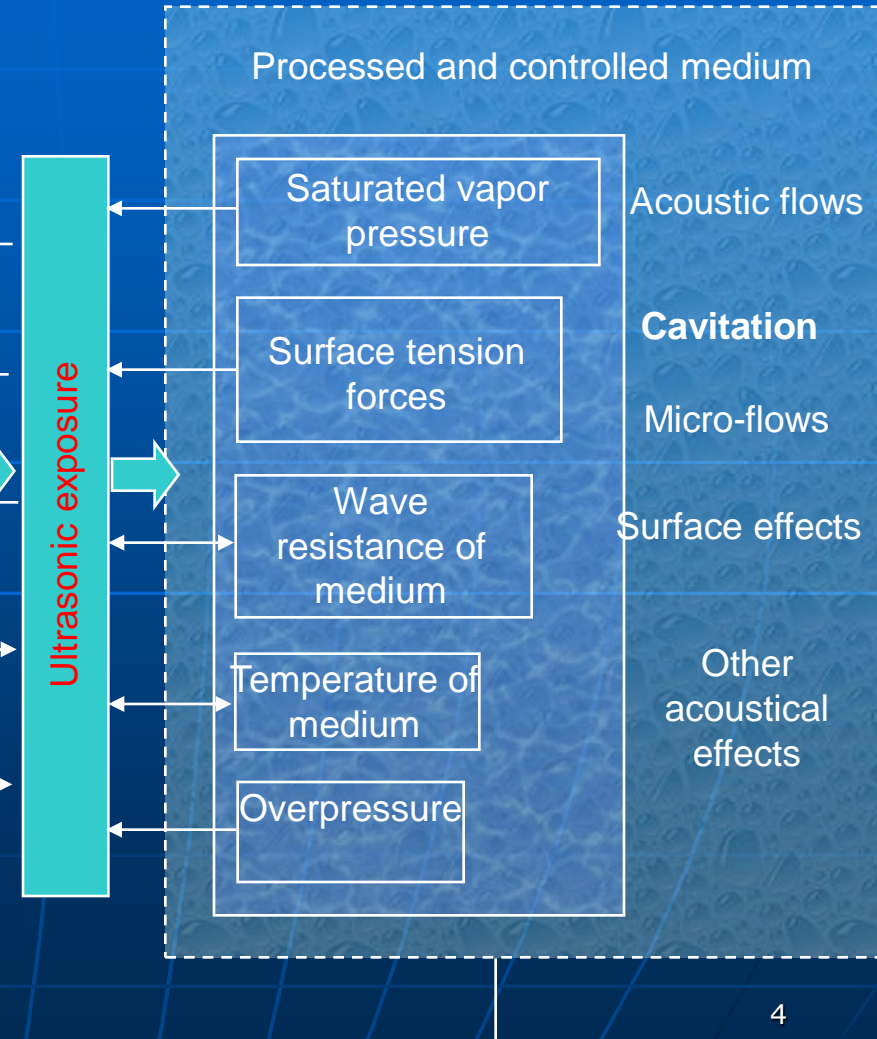
The absence of the criteria of continuous monitoring of the processing mediums parameters

Ultrasonic exposure

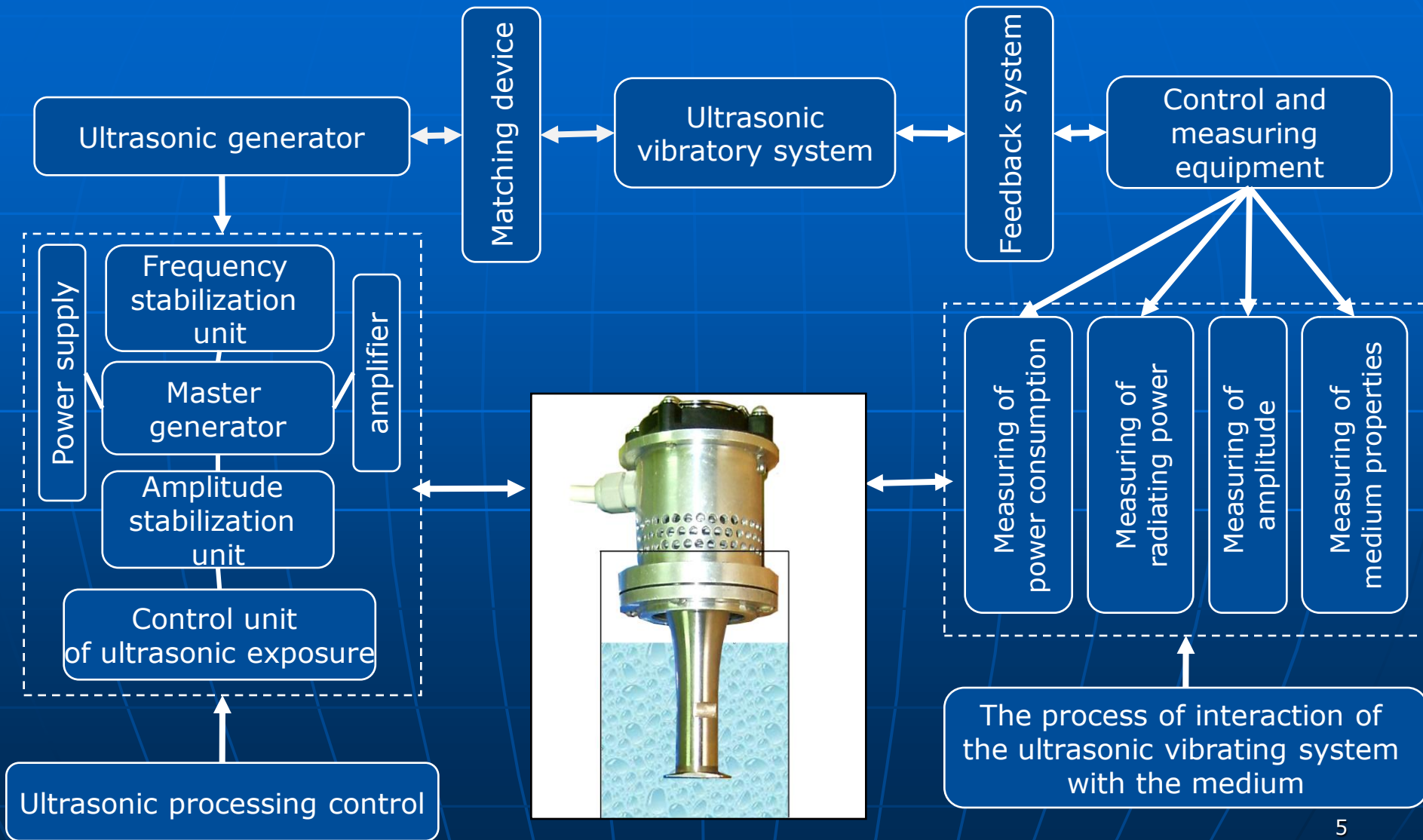
Ultrasonic industrial device



Technological process



Ultrasonic industrial device



Drilling of frozen soil with temperature of liquid nitrogen



Ultrasonic exposure of melted metal (T more than 1000 C)



Influence of liquid medium temperature

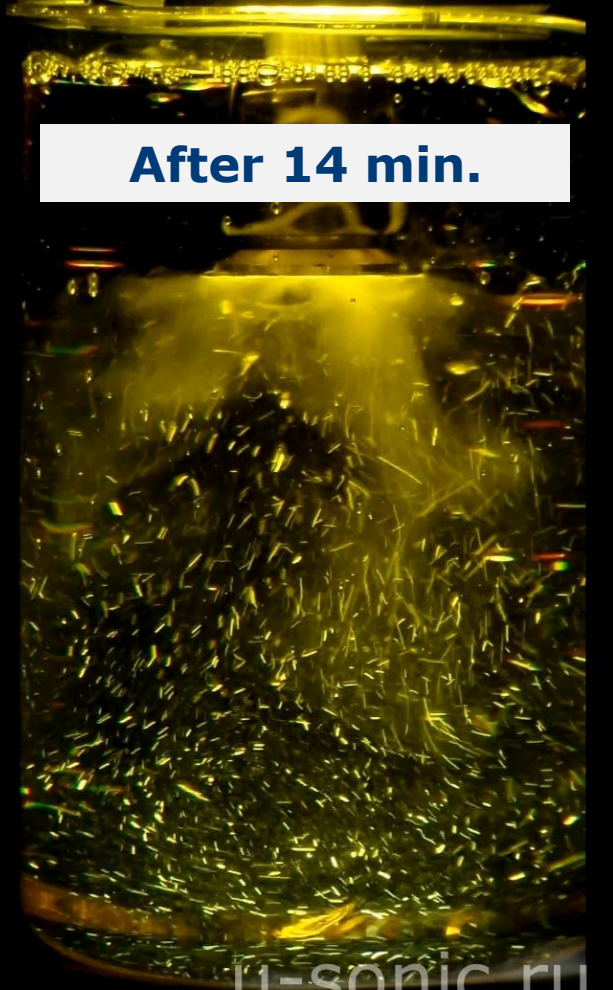
Initial



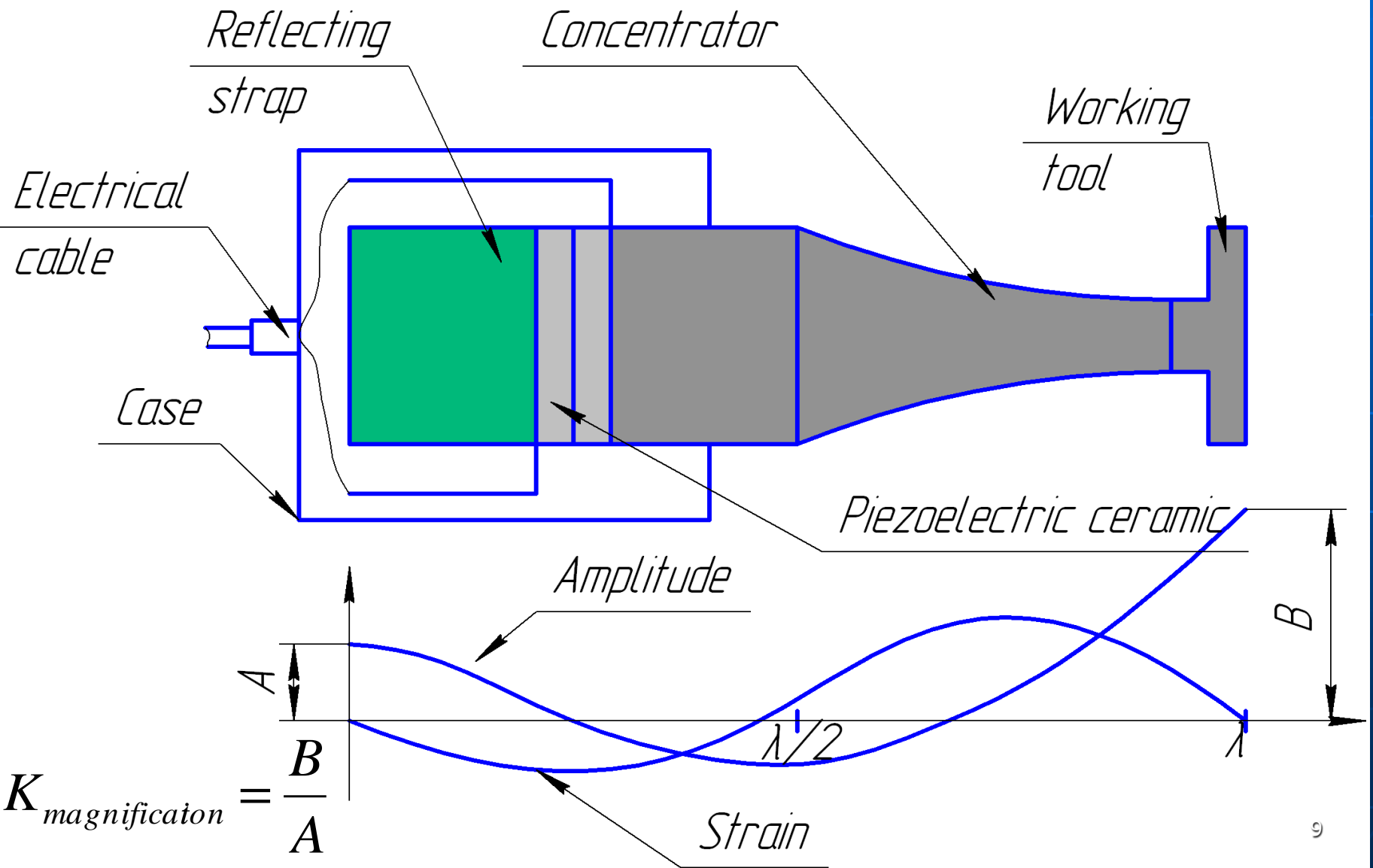
After 7 min.



After 14 min.



Ultrasonic oscillation system

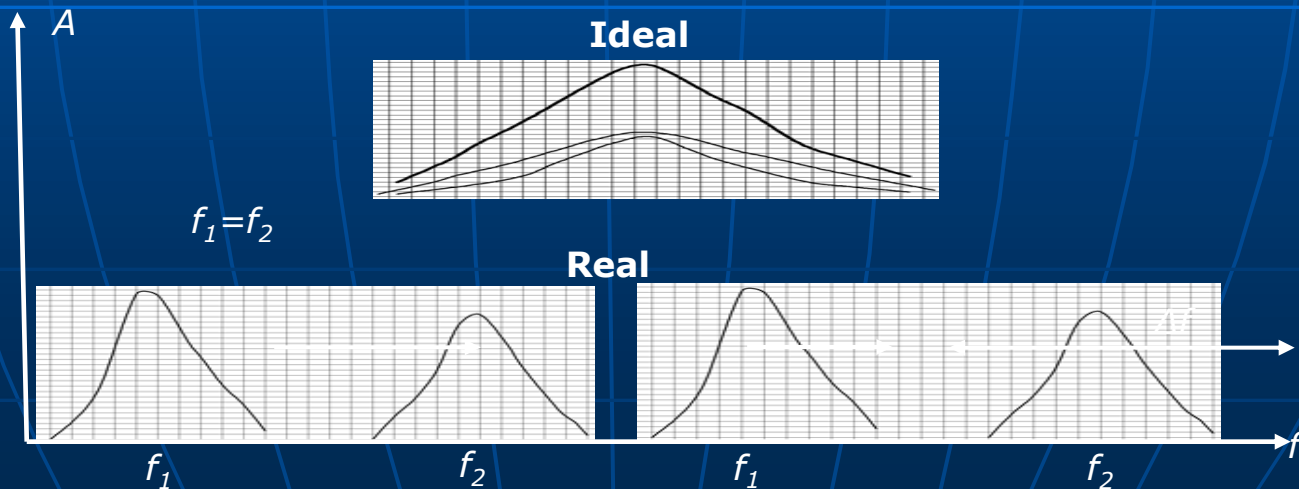
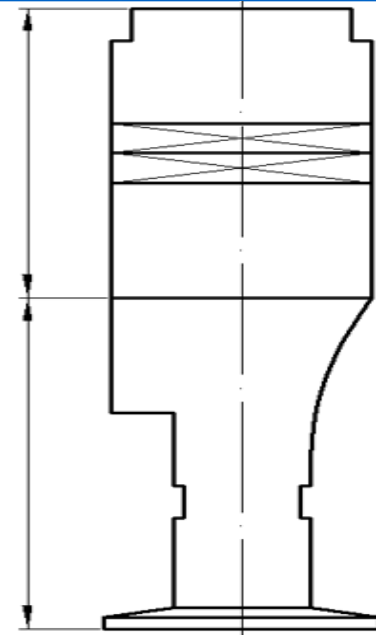


Main problem of vibratory system

1. Low efficiency (<50%)
2. High weight and length
3. Mismatch

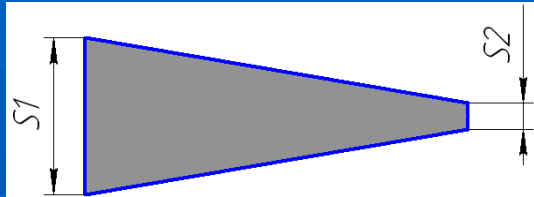
$$f_1 = \frac{2c_1}{\lambda_1}$$

$$f_2 = \frac{2c_2}{\lambda_2}$$



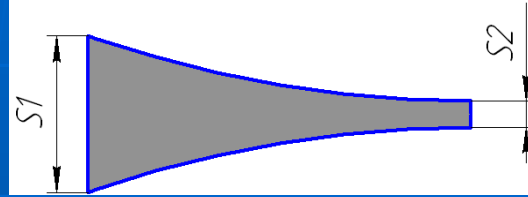
Magnifiers of ultrasonic oscillations

Conical



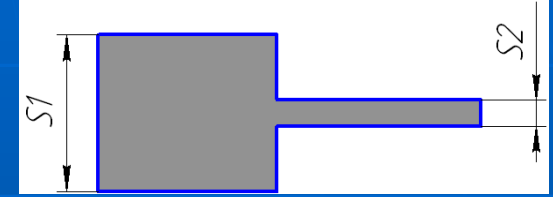
$$K = 0.8 \sqrt{\frac{S_1}{S_2}} \quad Q = 40$$

Exponential



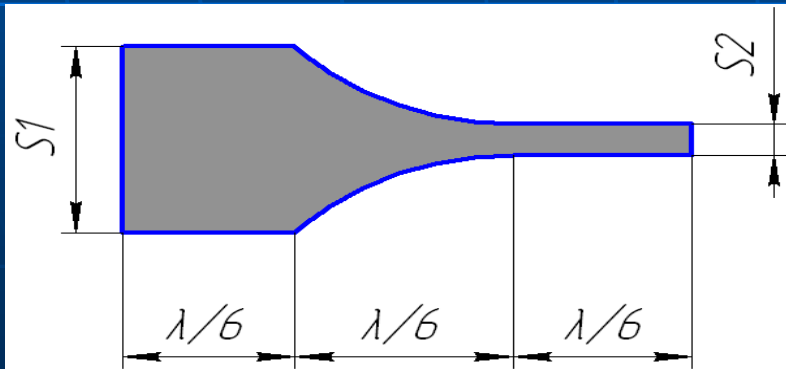
$$K = 1.1 \sqrt{\frac{S_1}{S_2}} \quad Q = 20$$

Stepping



$$K = \frac{S_1}{S_2} \quad Q = 150$$

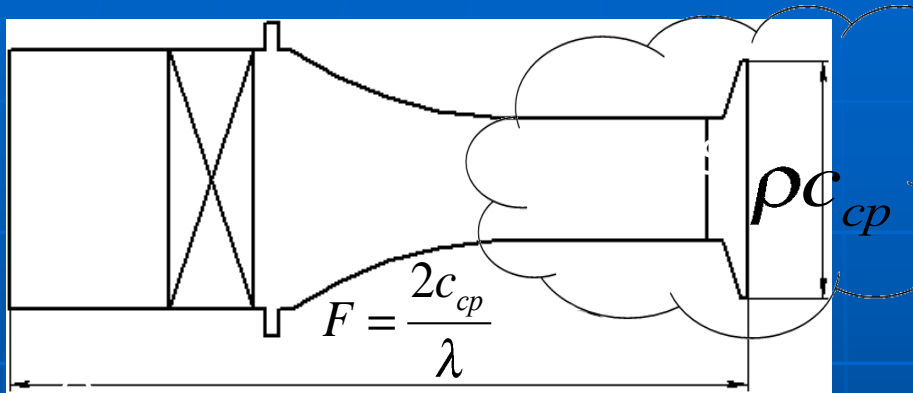
Stepping-exponential concentrator



$$K = (0.8 - 0.9) \frac{S_1}{S_2}$$



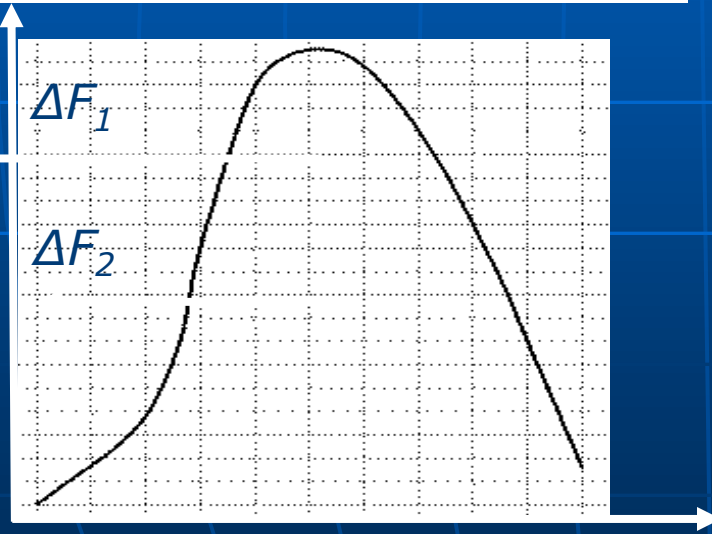
Half-wave vibratory system



Efficiency $\leq 80\%$

Vibration amplitude $\leq 100 \mu\text{m}$

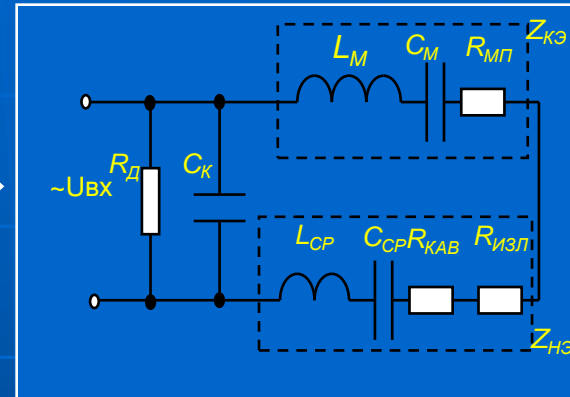
Gain factor ≥ 20



$$\Delta F_1 = f(S, \rho c_{\text{medium}})$$

$$\Delta F_2 = f(T, U)$$

Vibratory system as sensor of technological medium parameters



R_d – resistance of dielectric losses;

C_k – capacity of piezoelements;

$R_{мп}$ – mechanical loss resistance;

C_m – equivalent to the flexibility of the vibratory system material;

L_m – equivalent to the mass of the material of the vibratory system;

$C_{ср}, L_{ср}$ – elements that characterize the reactive properties of the processing medium;

$R_{изл}$ – element that characterizes the wave resistance of the medium;

$R_{кав}$ – an element that characterizes the energy costs for the creation and maintenance of cavitation;

$Z_{кэ}$ – impedance of the vibratory system;

$Z_{нэ}$ – impedance of the acoustic load.

$$z = (z_{кэ} + z_{нэ});$$

$$z_{нэ} = f(R_{кав}; R_{изл}; L_{ср});$$

$$R_{изл} = f(\rho_{ср} c_{ср}) - \text{output energy};$$

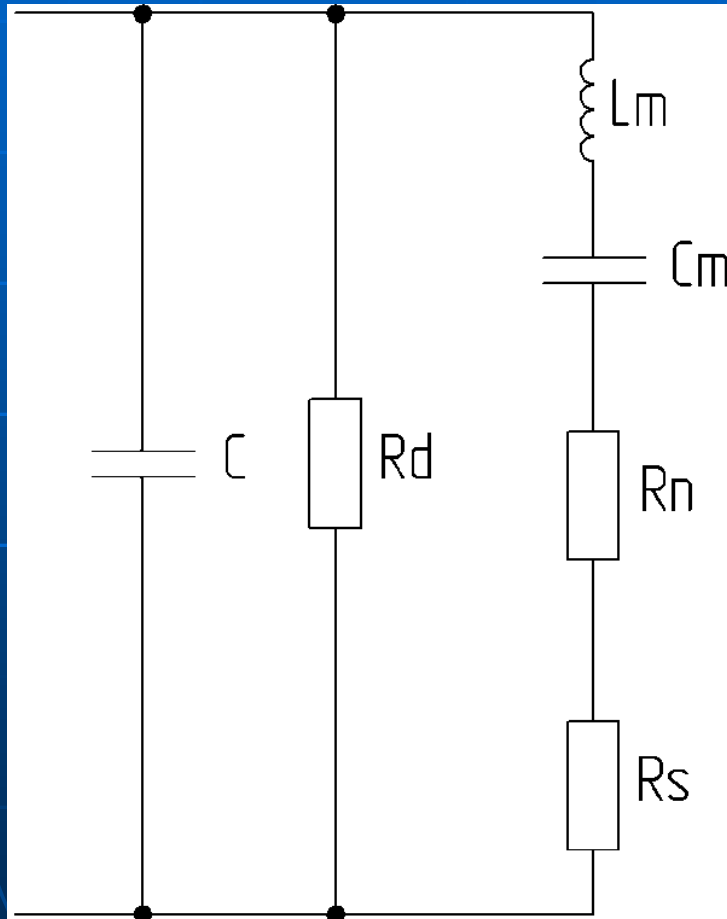
$$L_{ср} = f(m_{присоед.}) = f(\rho_{ср})$$

Resonance properties;

$$f_{рез} = f(\rho_{ср}).$$

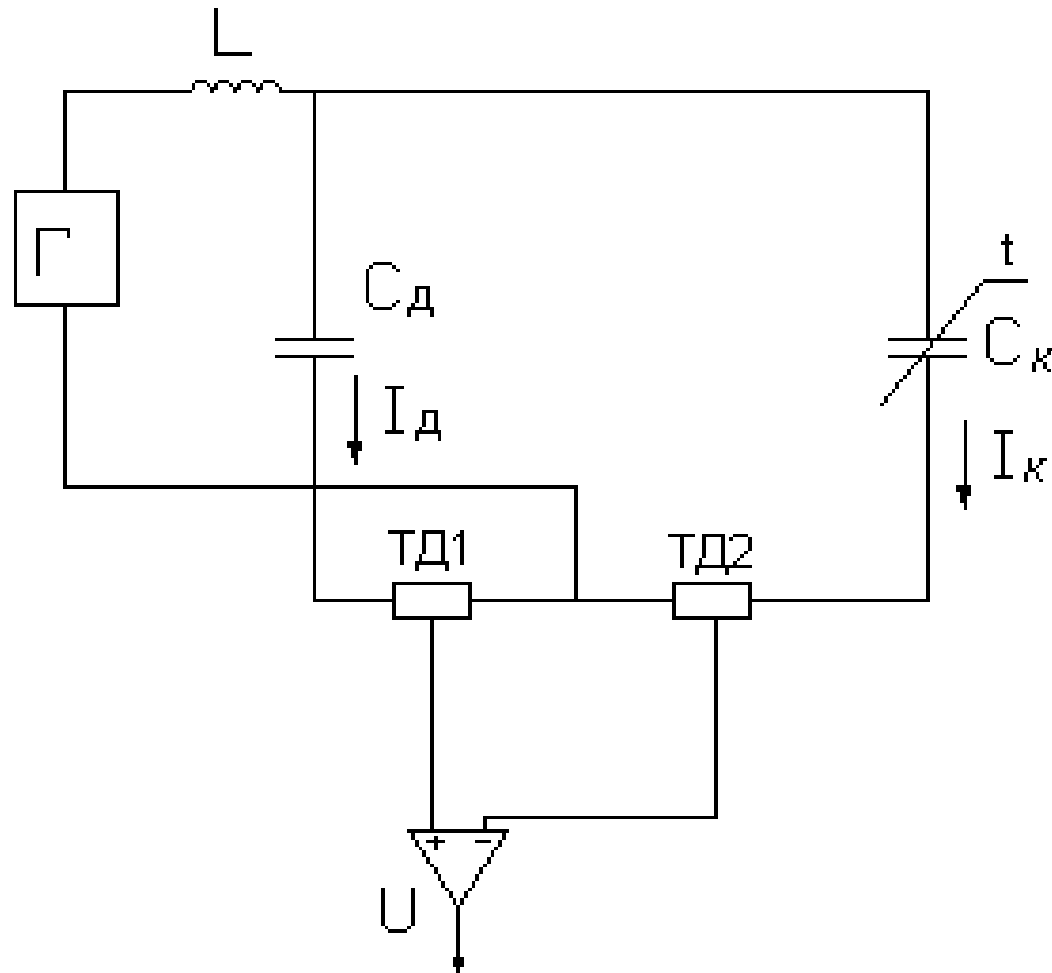
On the basis of the electrical equivalent circuit of the vibratory system, the dependences of its electrical parameters on the characteristics of the acoustic load and its own properties are obtained. This is makes it possible to measure the acoustic characteristics of medium.

A model of the vibratory system as a physical equivalent circuit

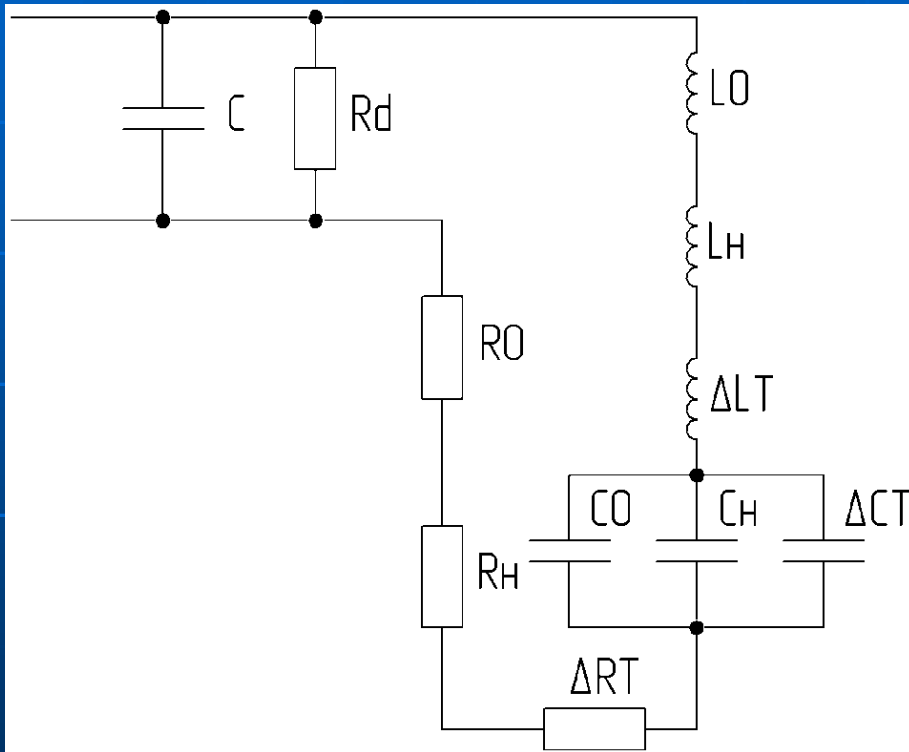


C – static capacity of piezoelements;
 R_d – dielectric loss resistance;
 L_m – mechanical branch inductance (equivalent to the vibrating mass of the transducer);
 C_m – mechanical branch capacity (equivalent to flexibility);
 R_n – mechanical loss resistance;
 R_s – radiation resistance.

Control system



A vibratory system model that takes into account the medium parameters



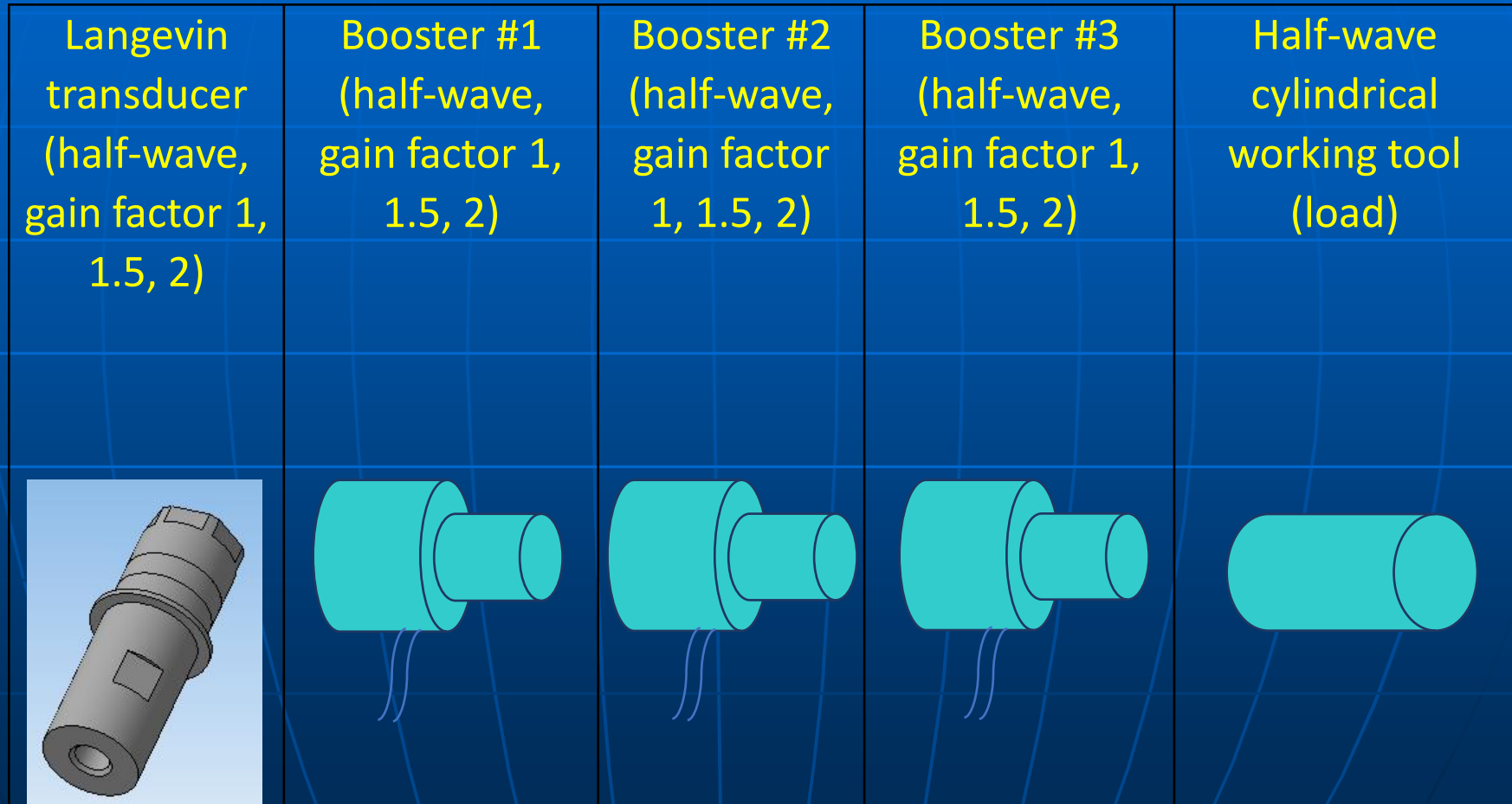
C – static capacity of piezoelements;
 R_d – dielectric loss resistance of piezoelements;
 L_O – inductance of the ultrasonic vibratory system;
 C_O – capacitance of the ultrasonic vibratory system;
 R_O – active resistance of the ultrasonic vibratory system;
 L_H – acoustic load inductance;
 C_H – acoustic load capacity;
 R_H – active resistance of the acoustic load;
 ΔL_T – additional inductance caused by a change in propagation conditions;
 ΔC_T – additional capacitance caused by a change in propagation conditions;
 ΔR_T – additional capacitance caused by a change in propagation conditions.

Change in propagation conditions is changing the properties and structure of medium.

THE AIM OF THE RESEARCH IS IDENTIFICATION OF DEPENDENCIES

- Influence of changes in the working tool (destruction) on the electrical parameters of the piezoelectric vibratory system.
- Influence of the destruction of the reflecting surface (of the object being destroyed) on the electrical parameters of the piezoelectric vibratory system.
- Influence of changes in the conditions of ultrasonic exposure (increase in distances, change in the properties of materials, deviation from resonant conditions) on the electrical parameters of a piezoelectric vibratory system

THE SCHEME OF REALIZATION OF PROCESSING BY A PIEZOELECTRIC VIBRATORY SYSTEM (CLASSICAL)



EQUIVALENT ELECTRICAL MODEL OF ULTRASONIC VIBRATORY SYSTEM

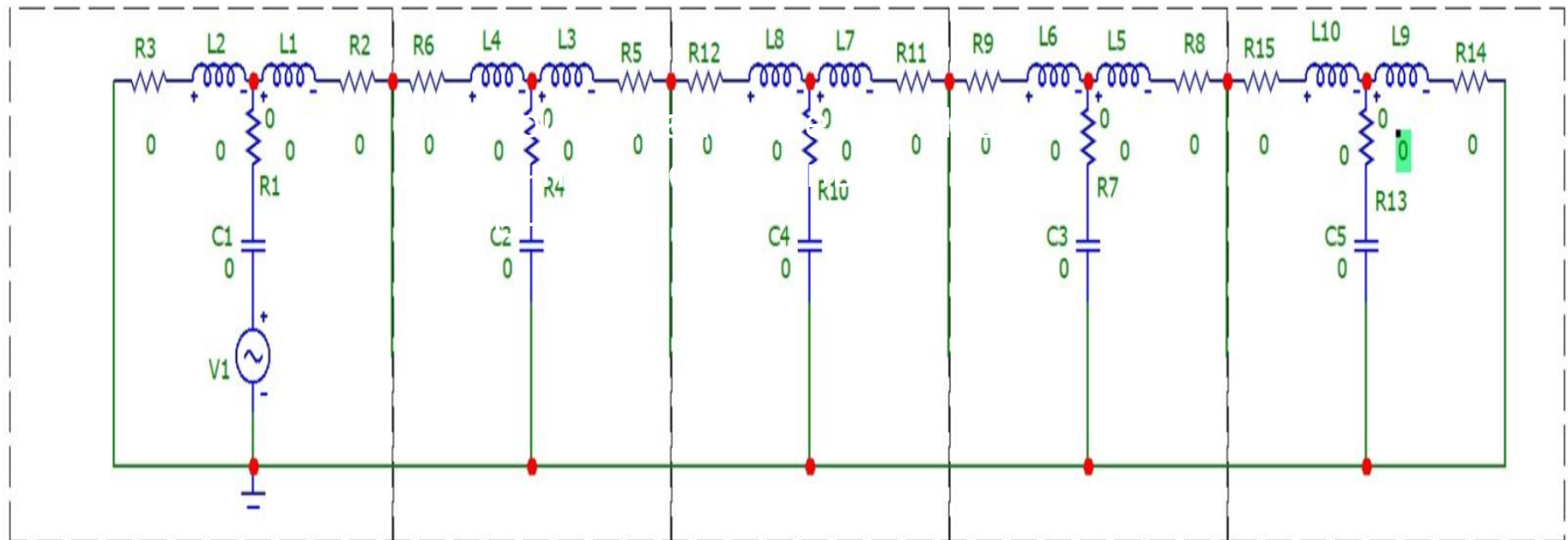
Transducer

Booster 1

Booster 2

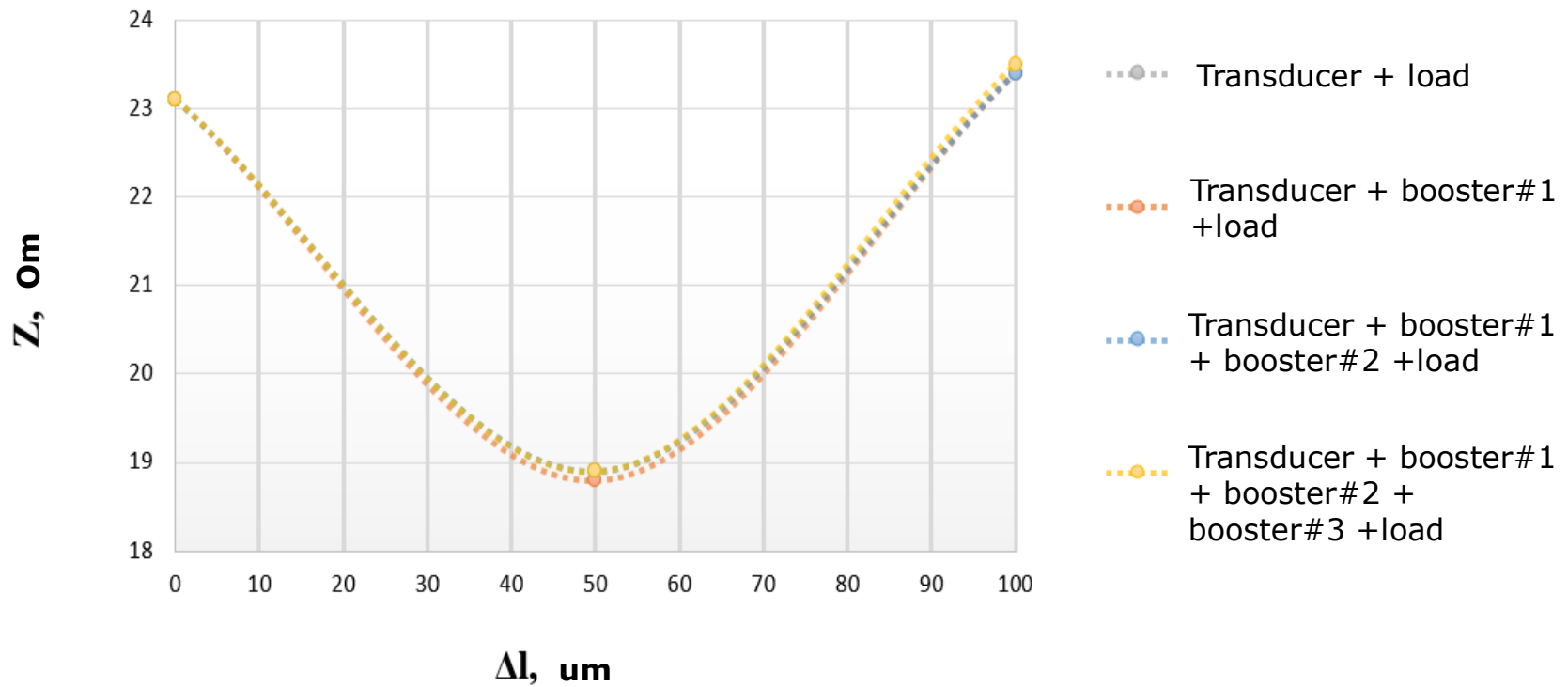
Booster3

Load

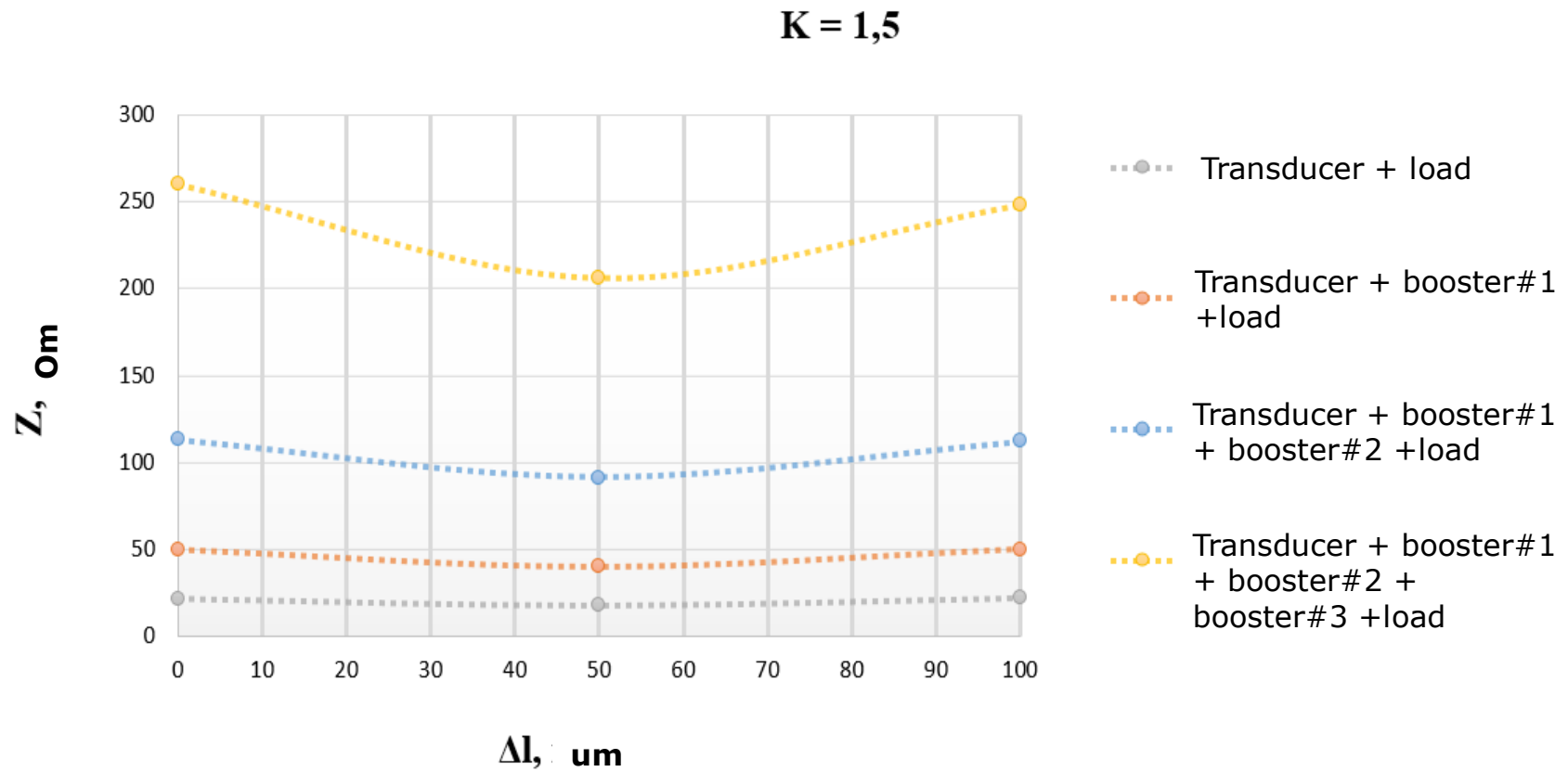


The dependence of the impedance on working tool abrasion for various construction of vibratory system

$K = 1$

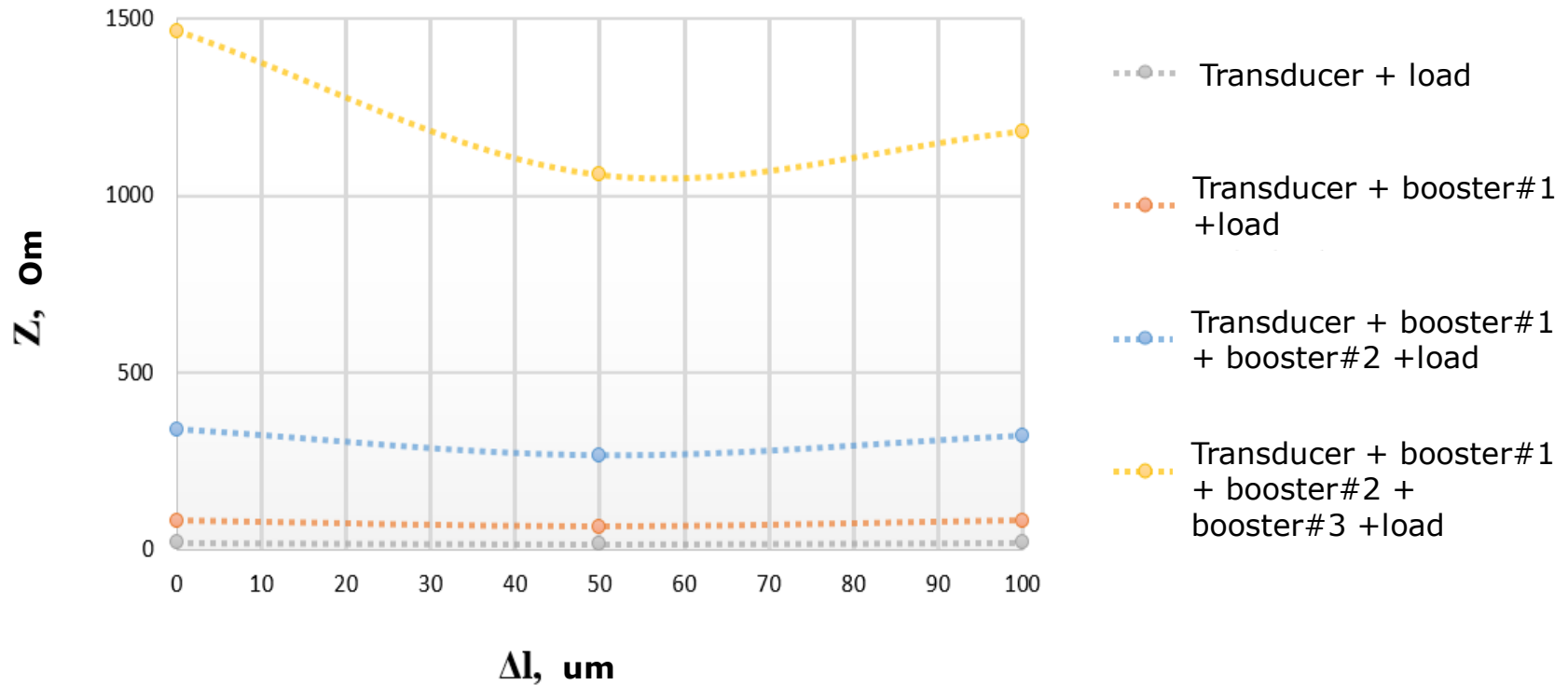


The dependence of the impedance on working tool abrasion for various construction of vibratory system



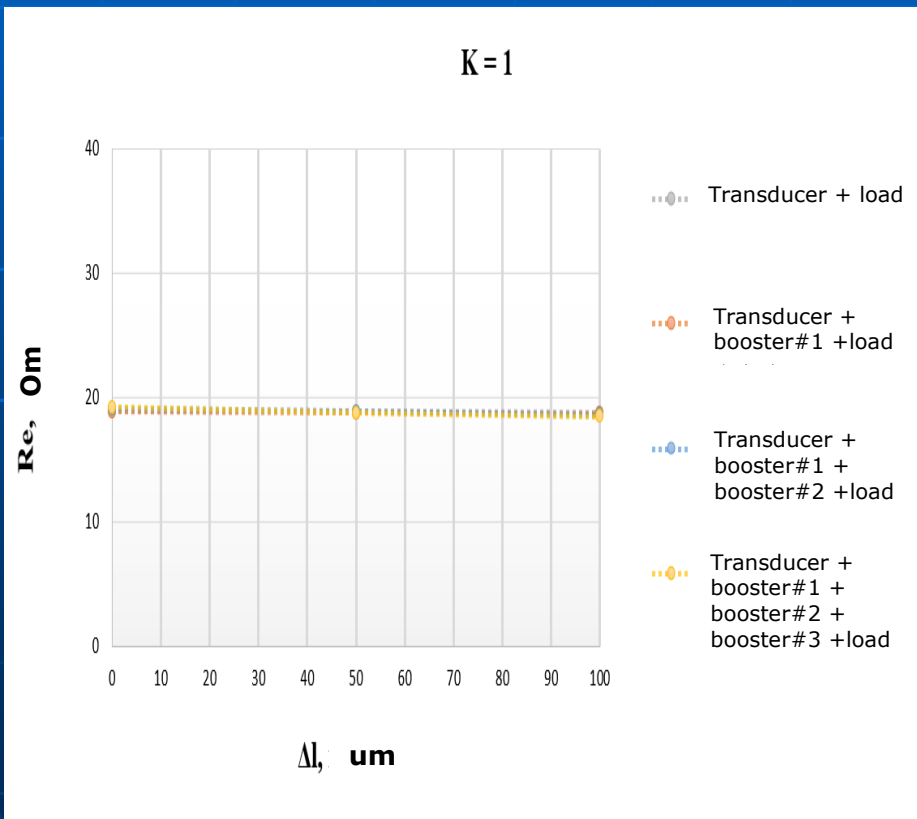
The dependence of the impedance on working tool abrasion for various construction of vibratory system

$K = 2$

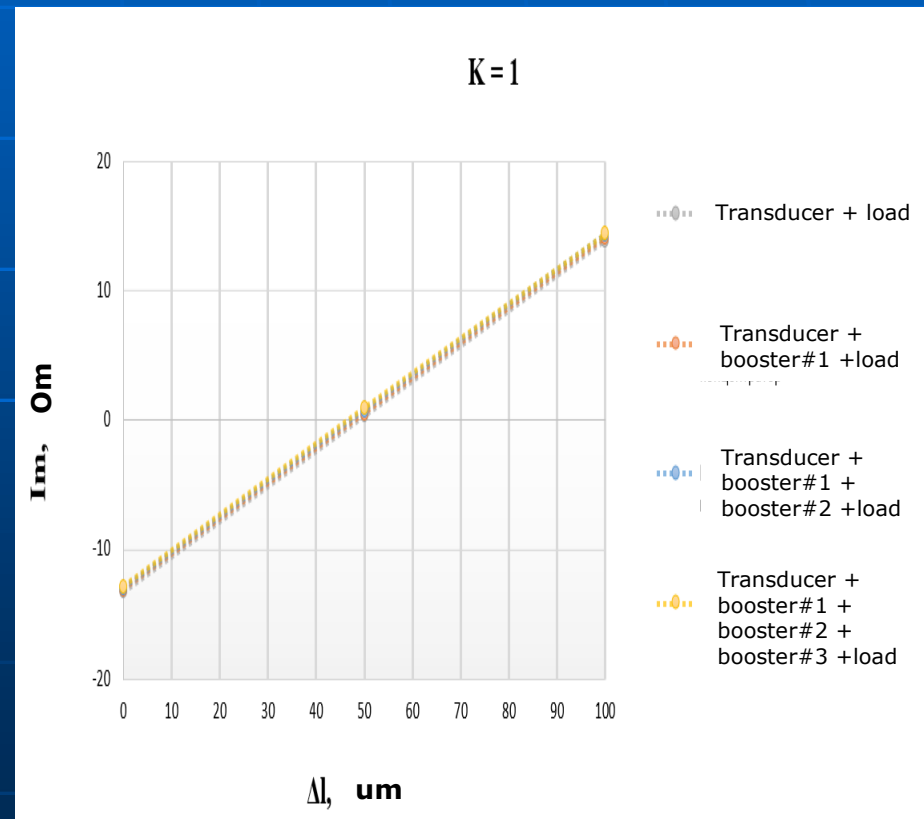


The dependence of the active and reactive resistance on working tool abrasion for various construction of vibratory system

Active resistance

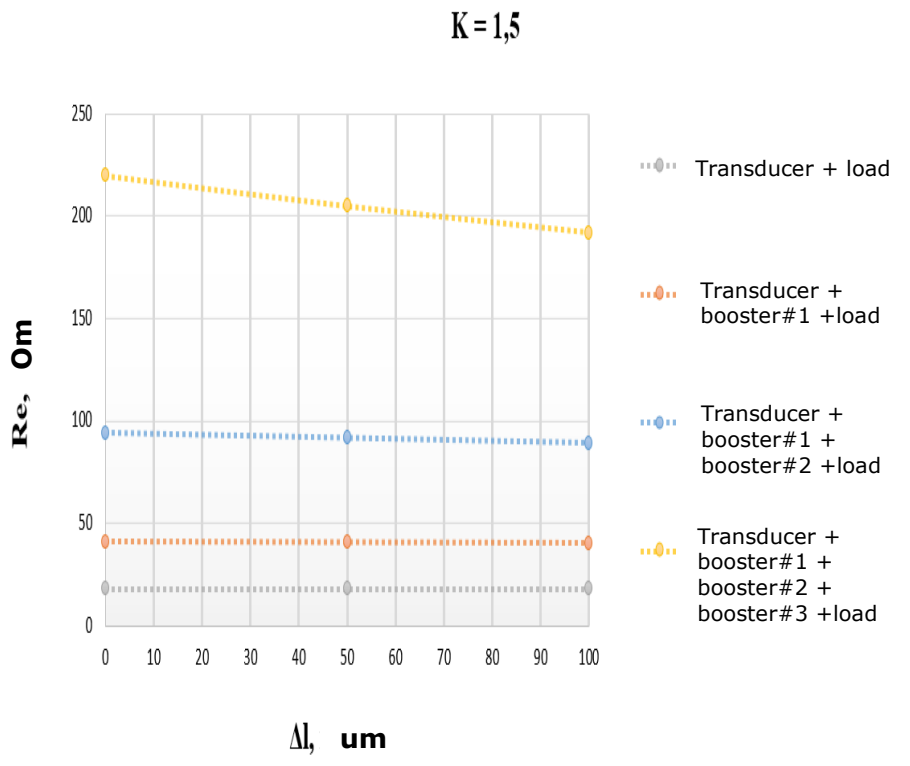


Reactive resistance

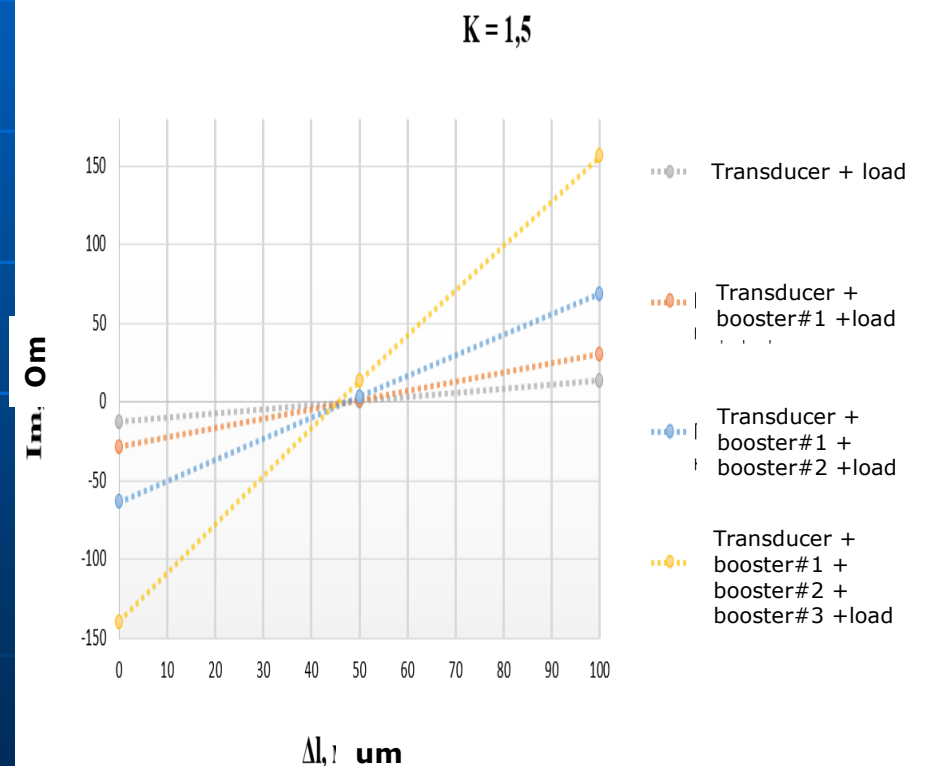


The dependence of the active and reactive resistance on working tool abrasion for various construction of vibratory system

Active resistance

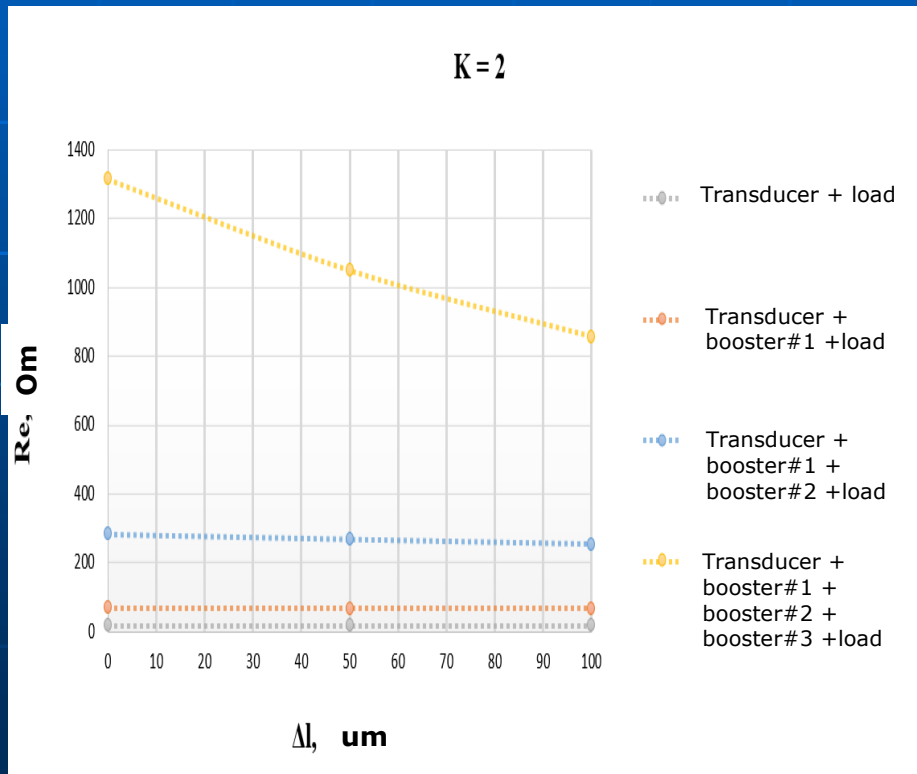


Reactive resistance

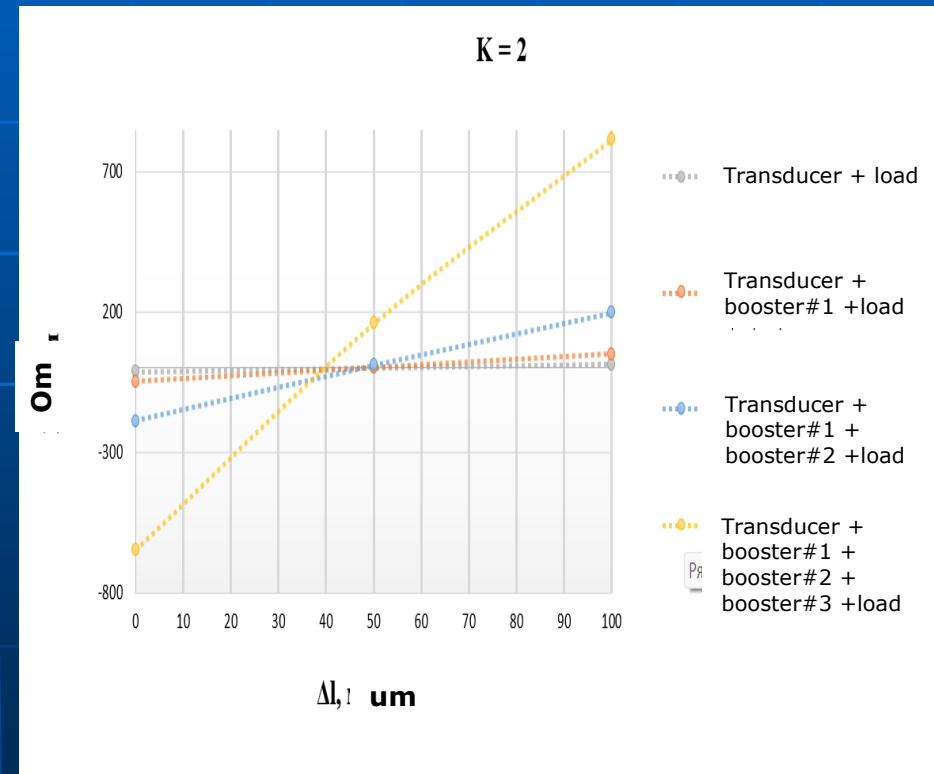


The dependence of the active and reactive resistance on working tool abrasion for various construction of vibratory system

Active resistance

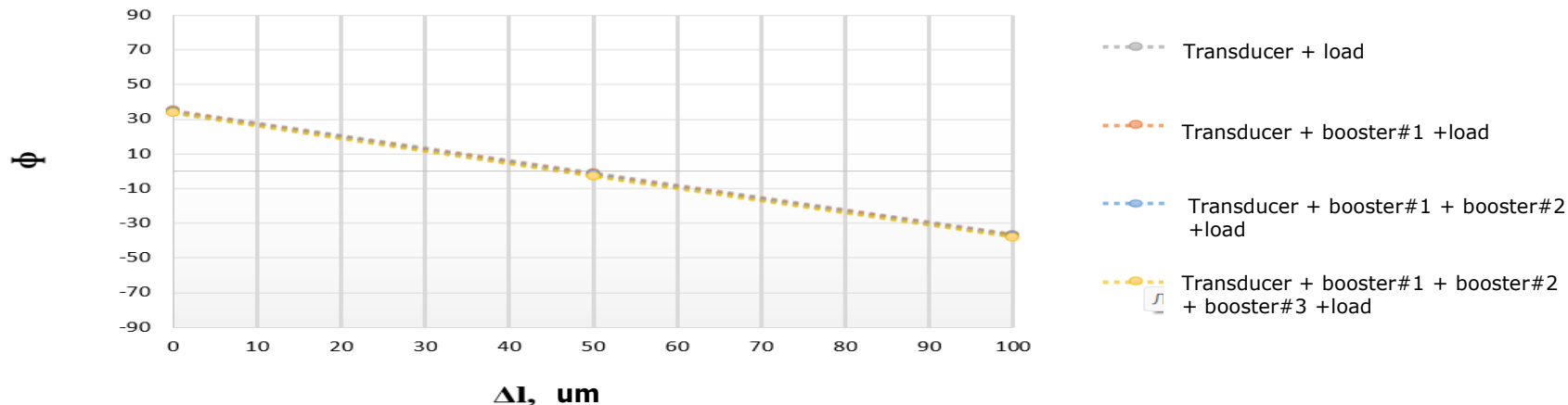


Reactive resistance

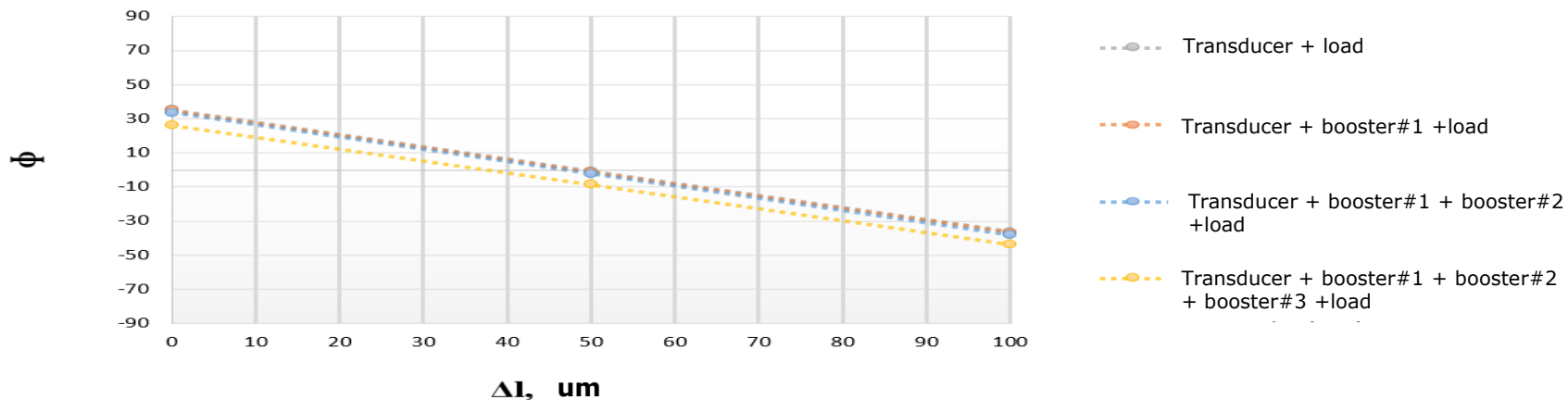


The dependence of the phase on vibratory system on working tool abrasion for various construction of vibratory system

K = 1



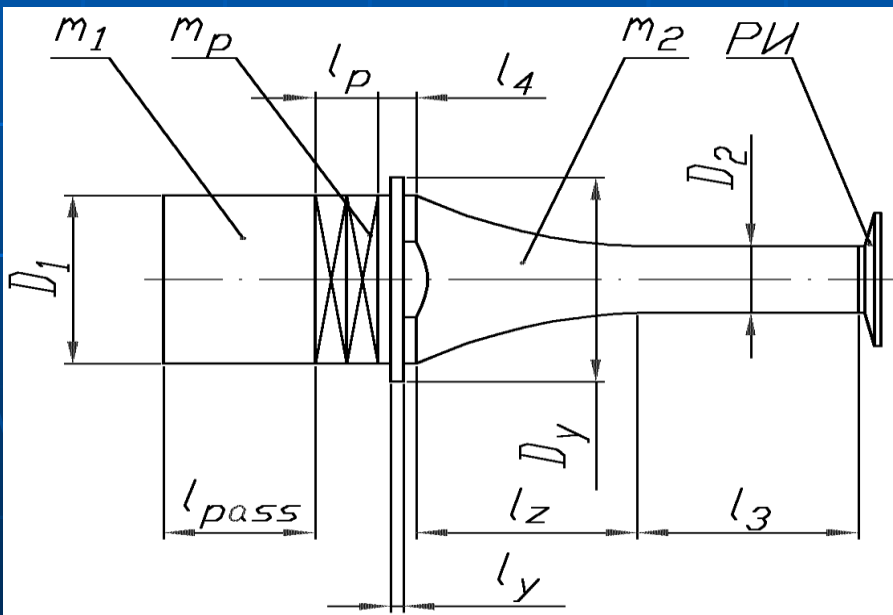
K = 2



THE SCHEME OF REALIZATION OF PROCESSING BY HALF-WAVE PIEZOELECTRIC VIBRATORY SYSTEM

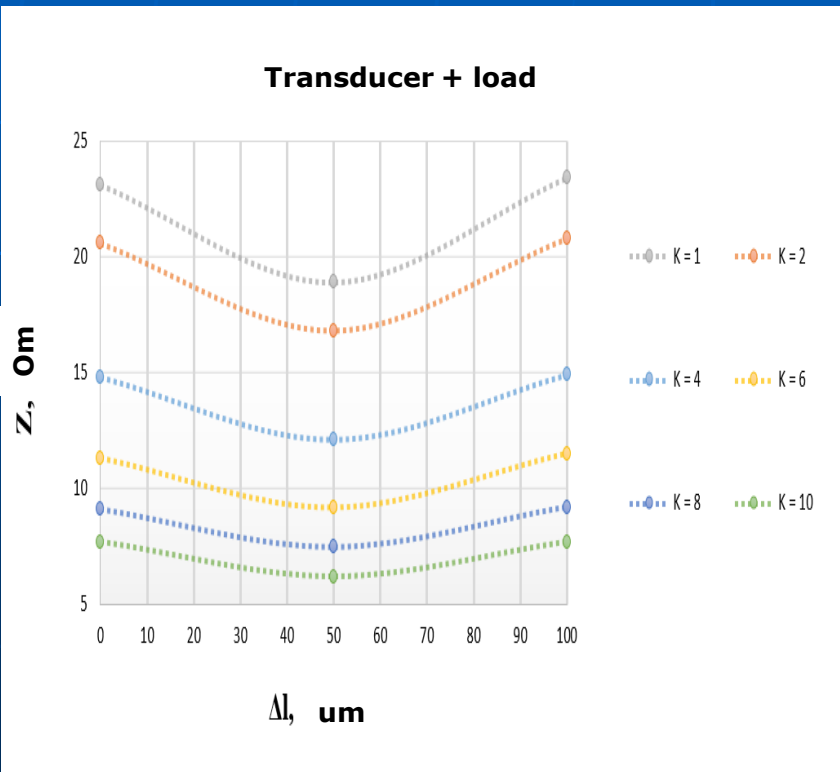
Transducer (half-wave, gain factor 1, 2, 4, 6, 8, 10)

Half-wave cylindrical test working tool (load)

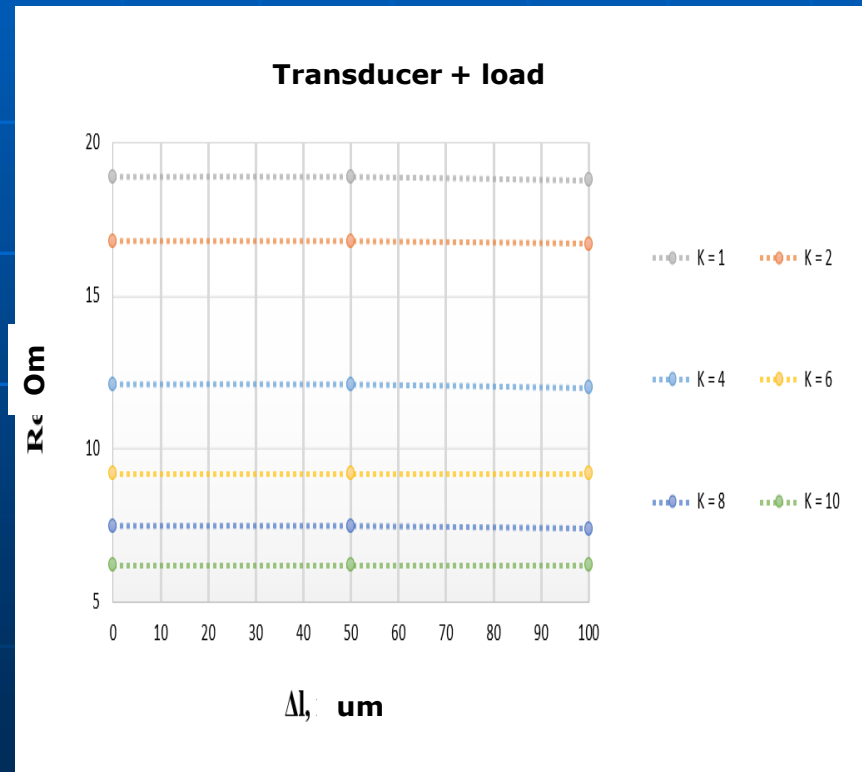


The dependence of resistance on working tool abrasion for various construction of vibratory system

Full wave resistance

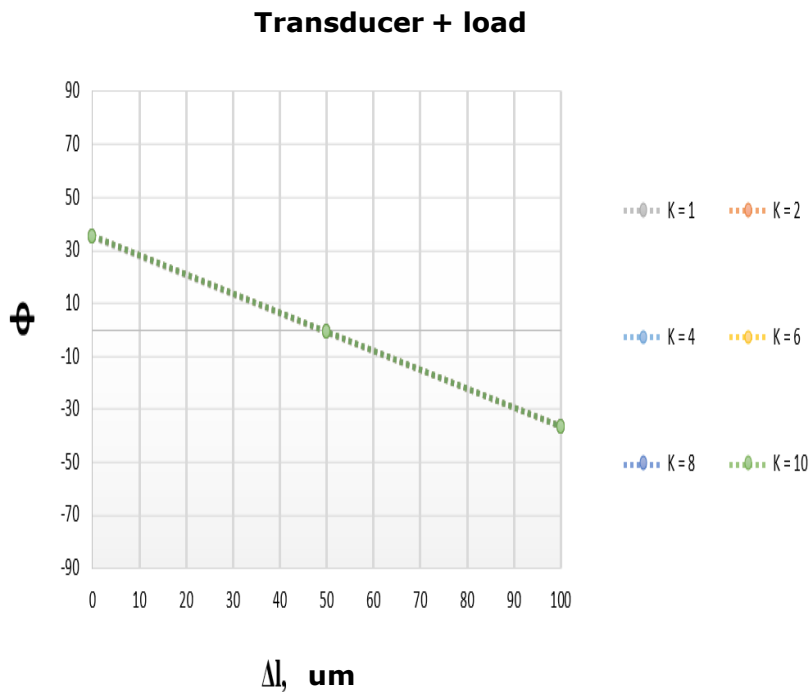


Active resistance

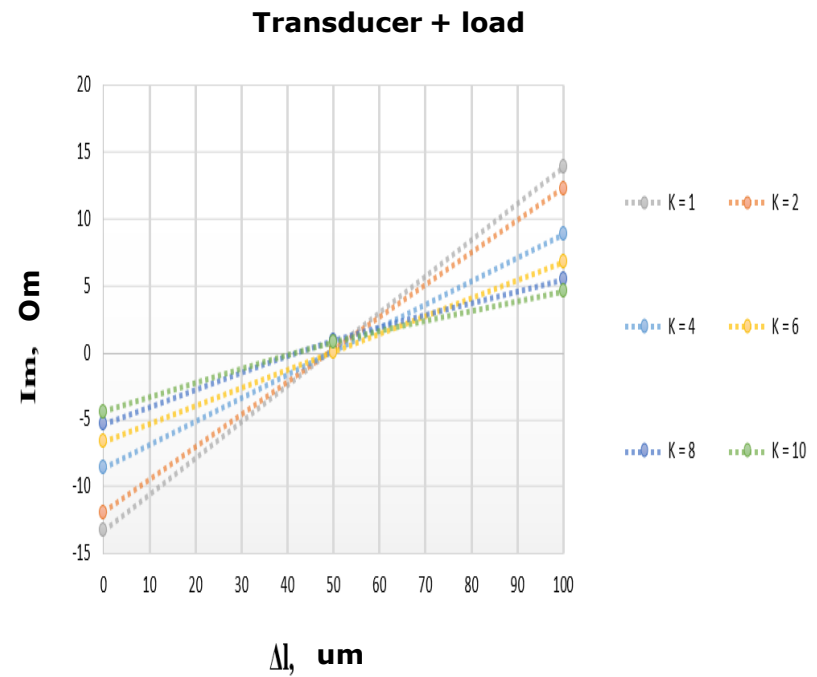


The dependence of phase and reactive resistance on working tool abrasion for various construction of vibratory system

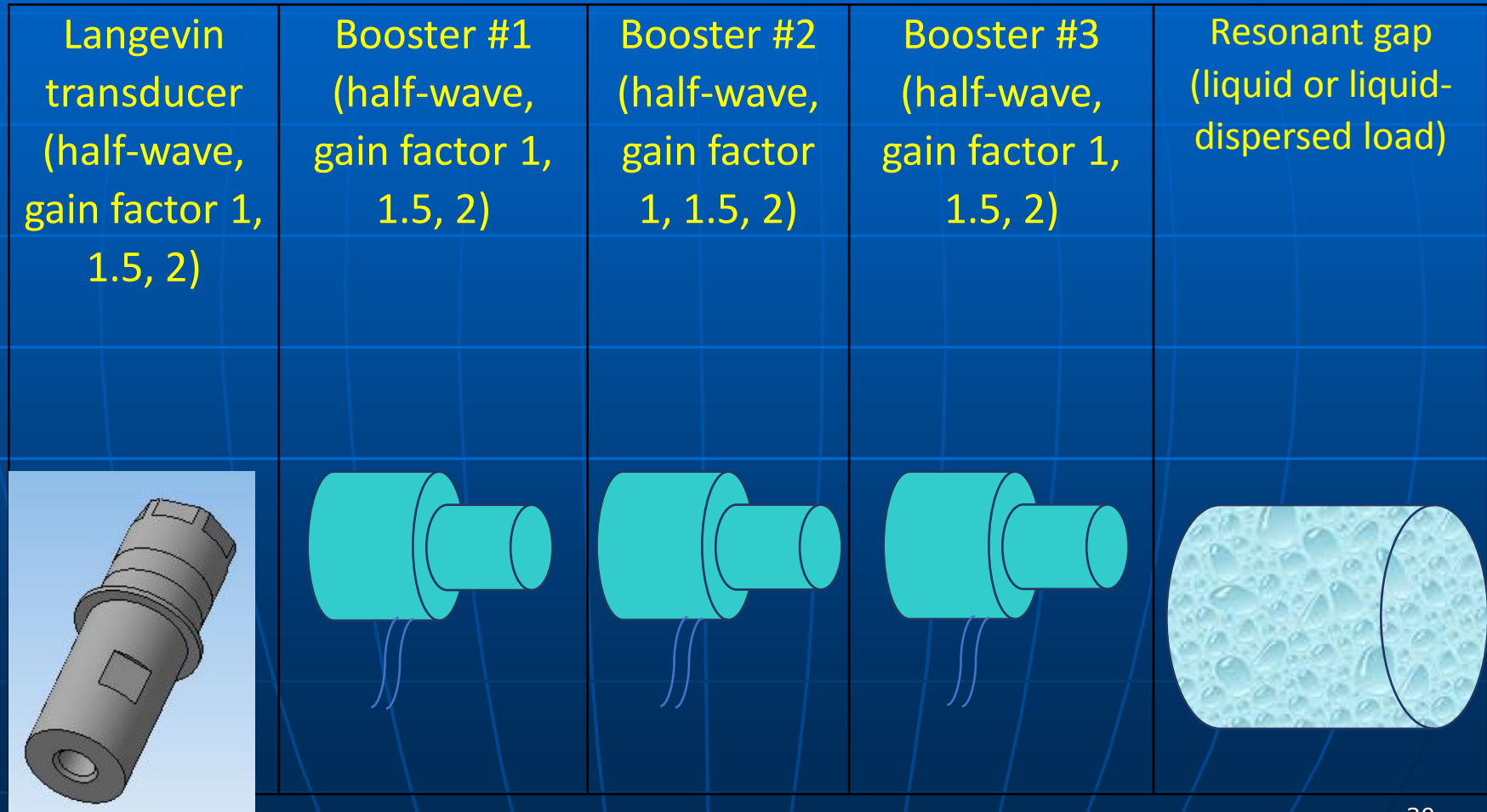
Phase



Reactive resistance

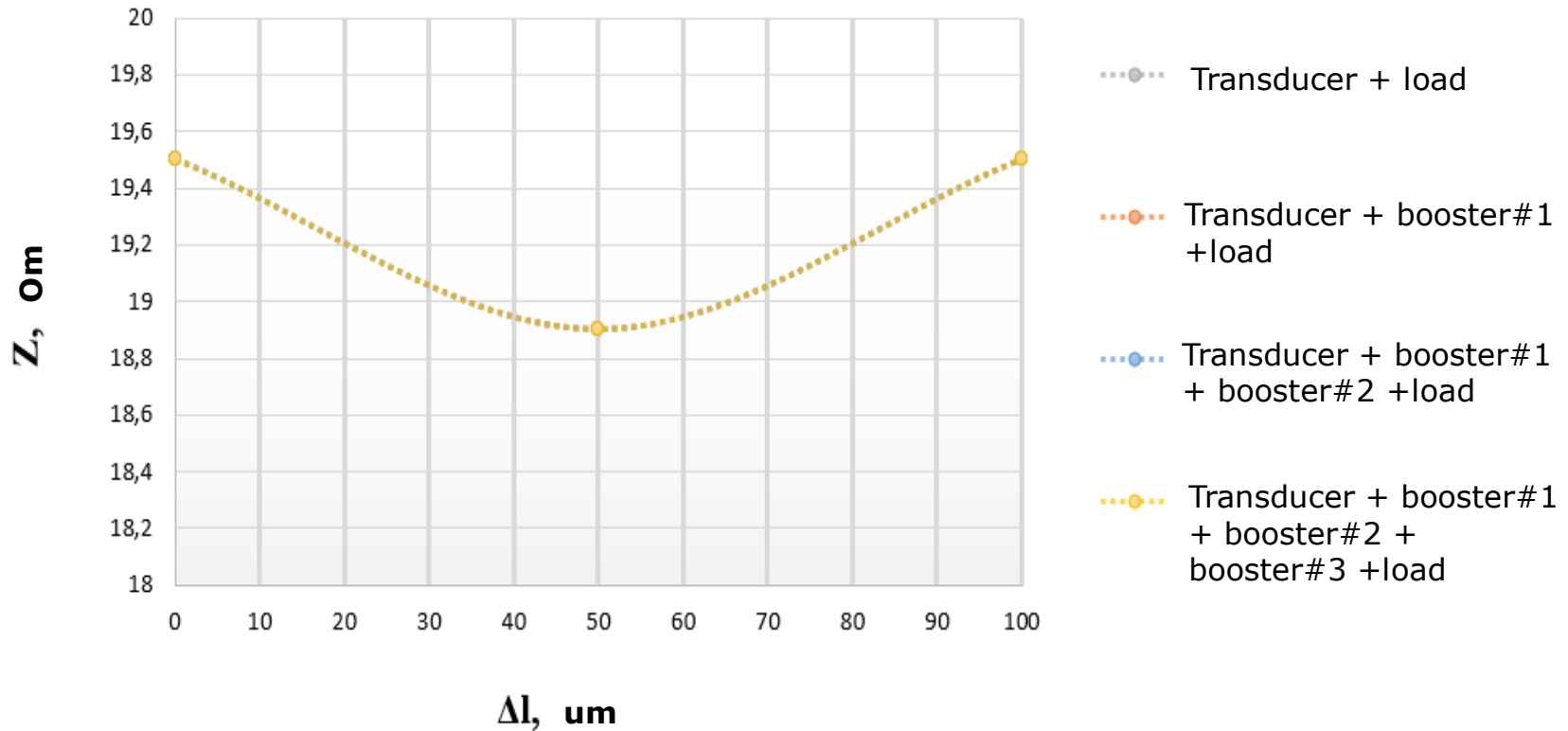


THE SCHEME OF ULTRASONIC EXPOSURE PROCESS



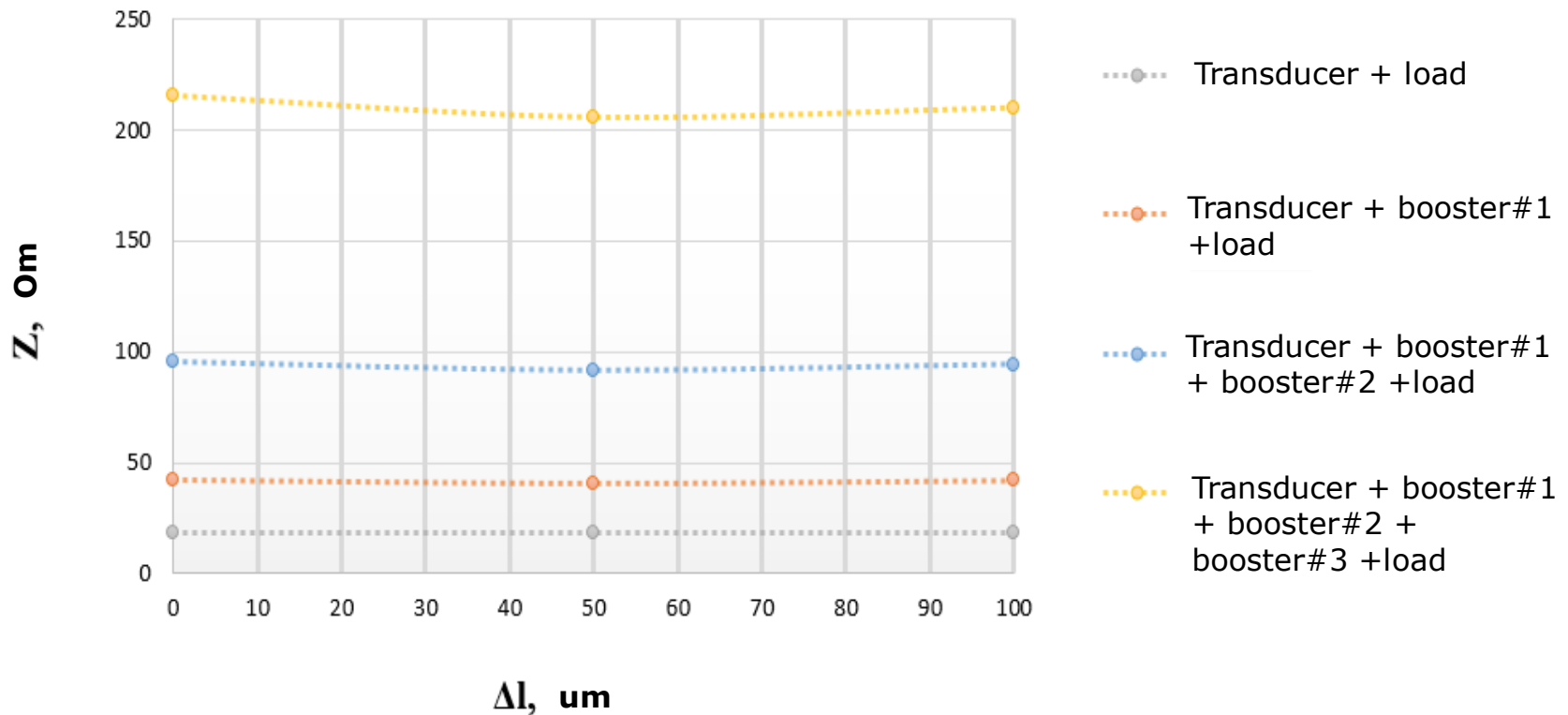
The dependence of impedance on working tool abrasion for various construction of vibratory system

$K = 1$



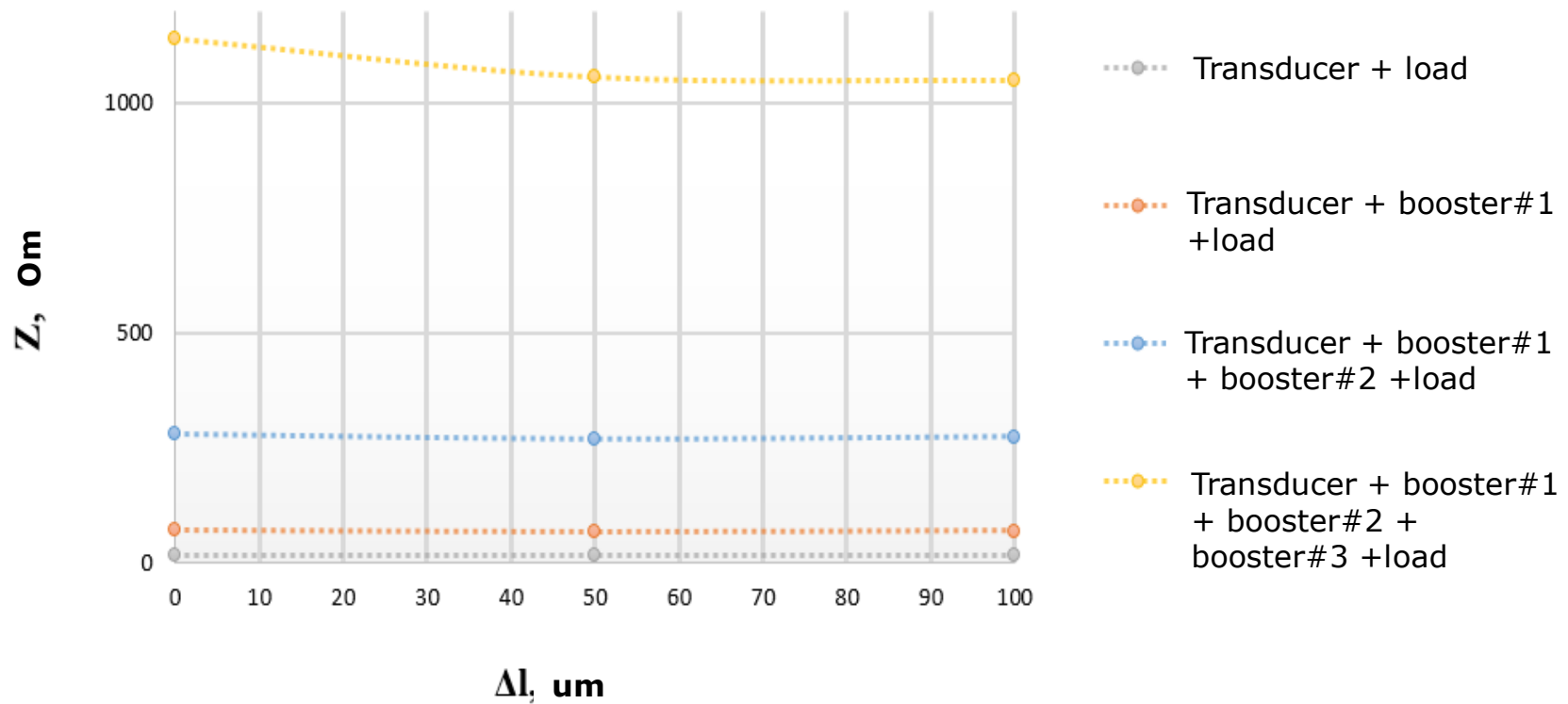
The dependence of impedance on working tool abrasion for various construction of vibratory system

$K = 1,5$



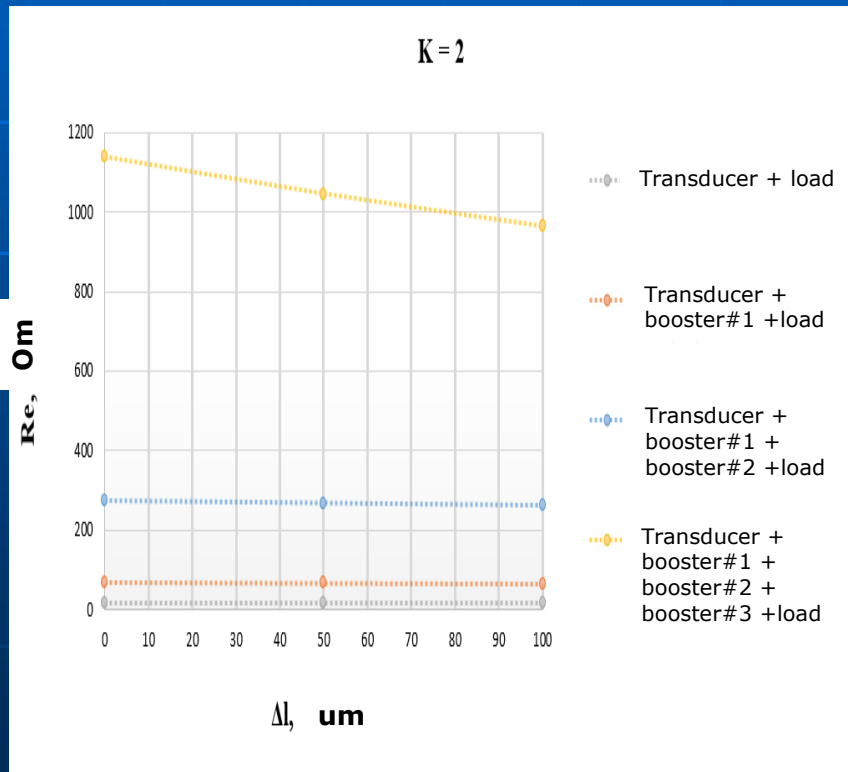
The dependence of impedance on working tool abrasion for various construction of vibratory system

$K = 2$

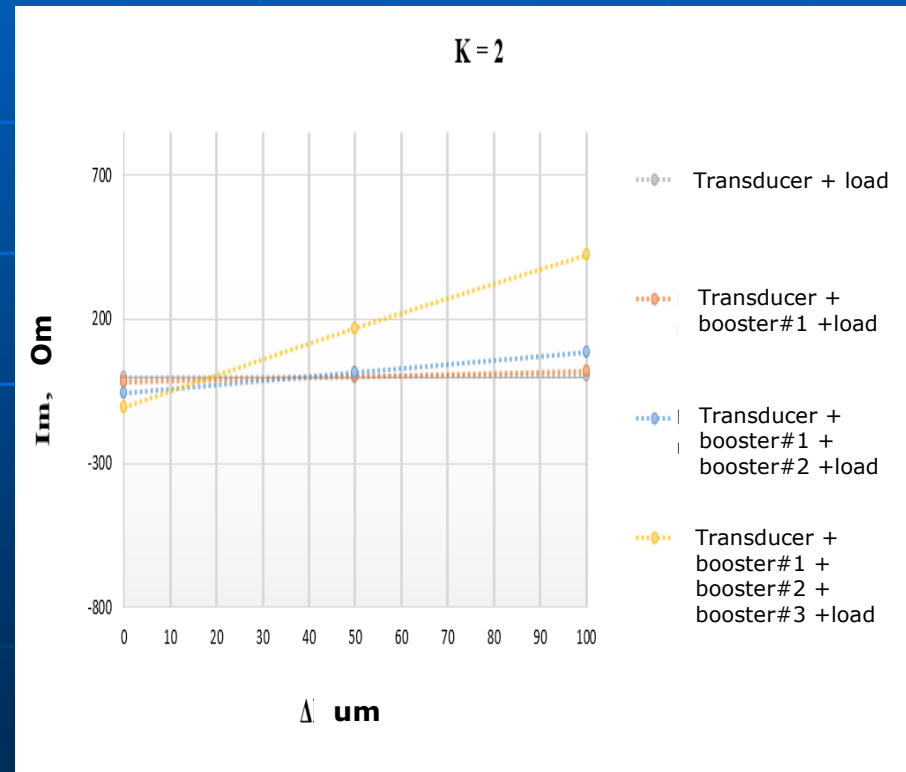


The dependence of the active and reactive resistance on change in propagation conditions for various construction of vibratory system

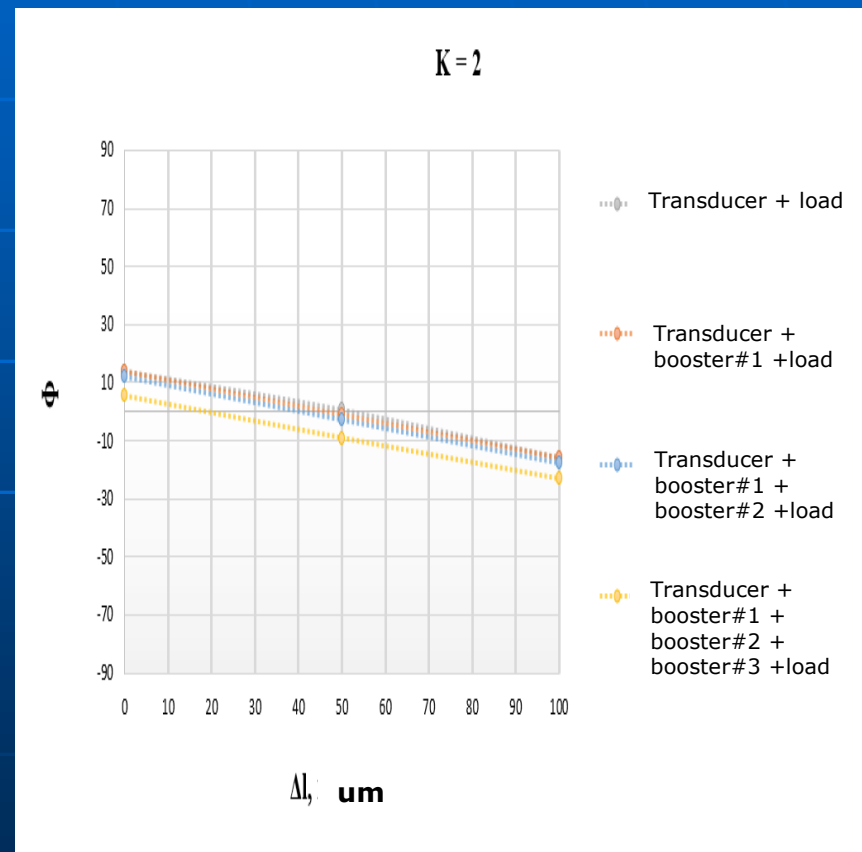
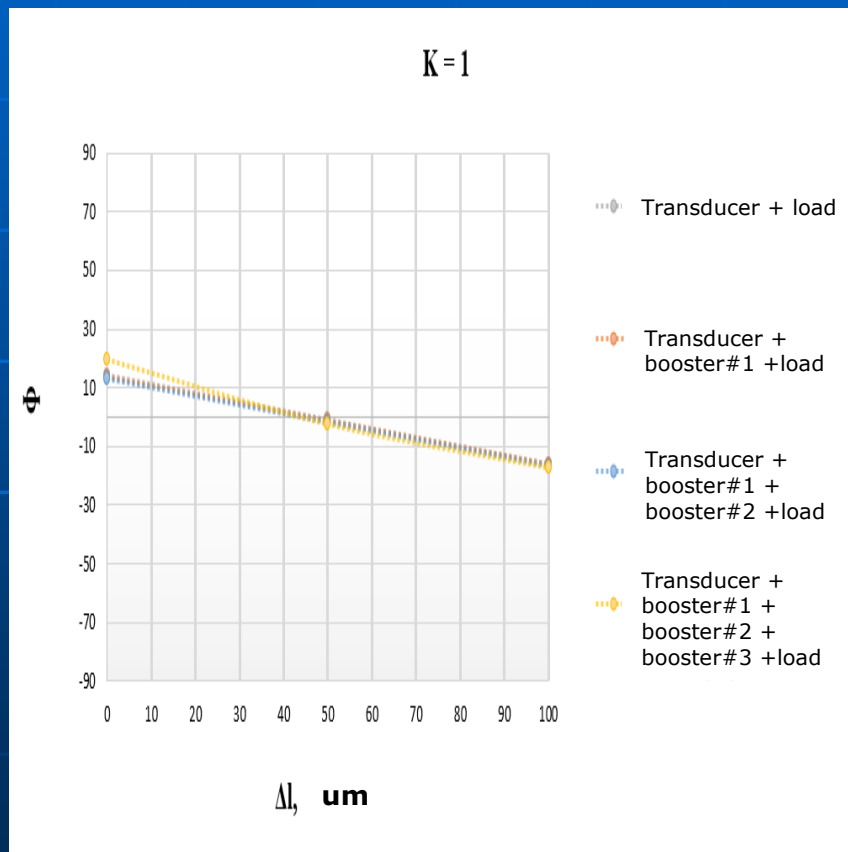
Active resistance



Reactive resistance



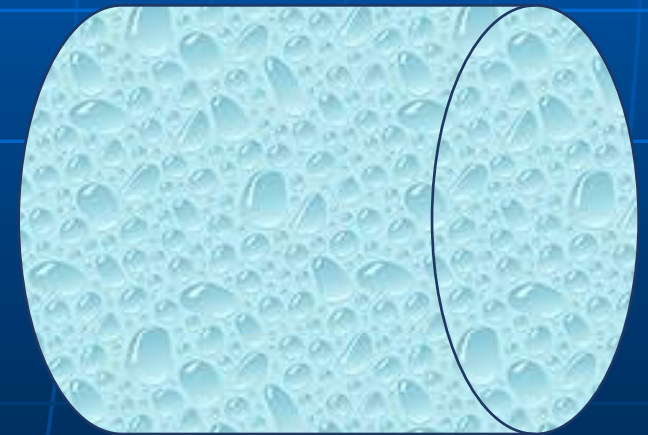
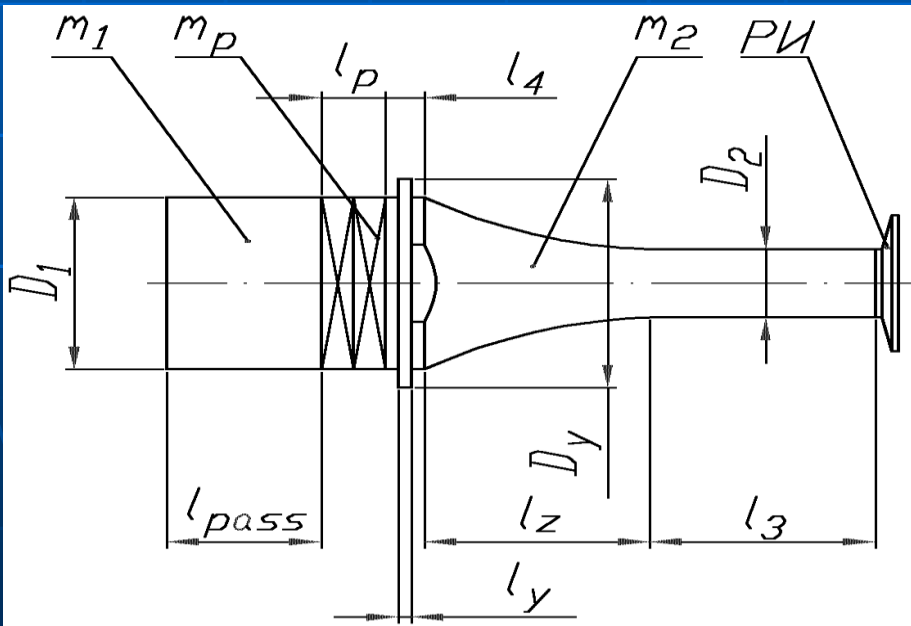
The dependence of the phase on change in propagation conditions for various construction of vibratory system



THE SCHEME OF REALIZATION OF PROCESSING BY A HALF-WAVE PIEZOELECTRIC SYSTEM

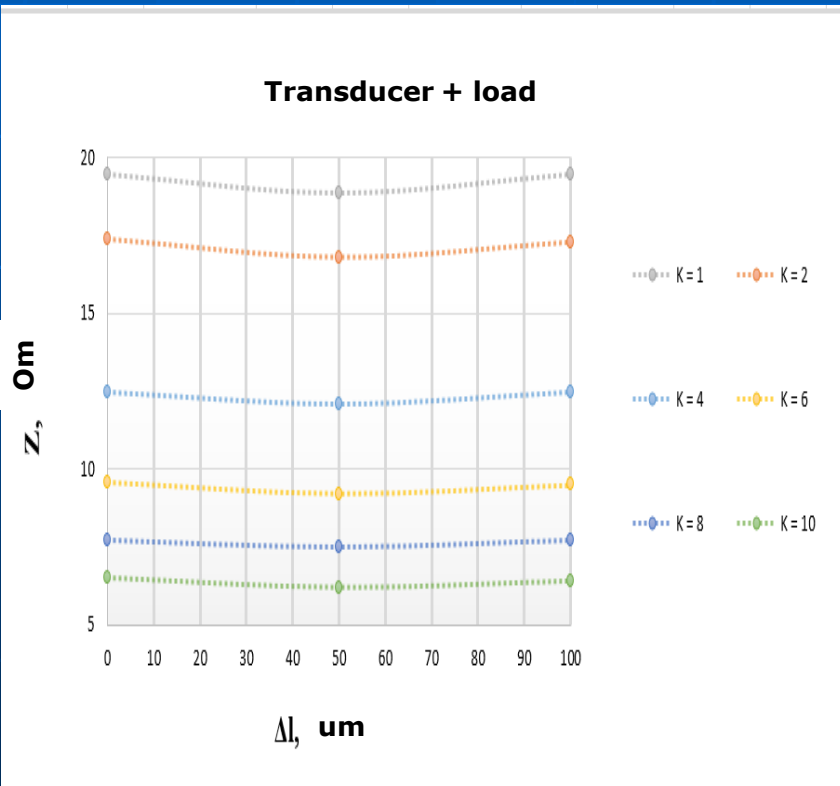
Transducer (half-wave, gain factor 1, 2, 4, 6, 8, 10)

Resonant gap (liquid or liquid-dispersed load)

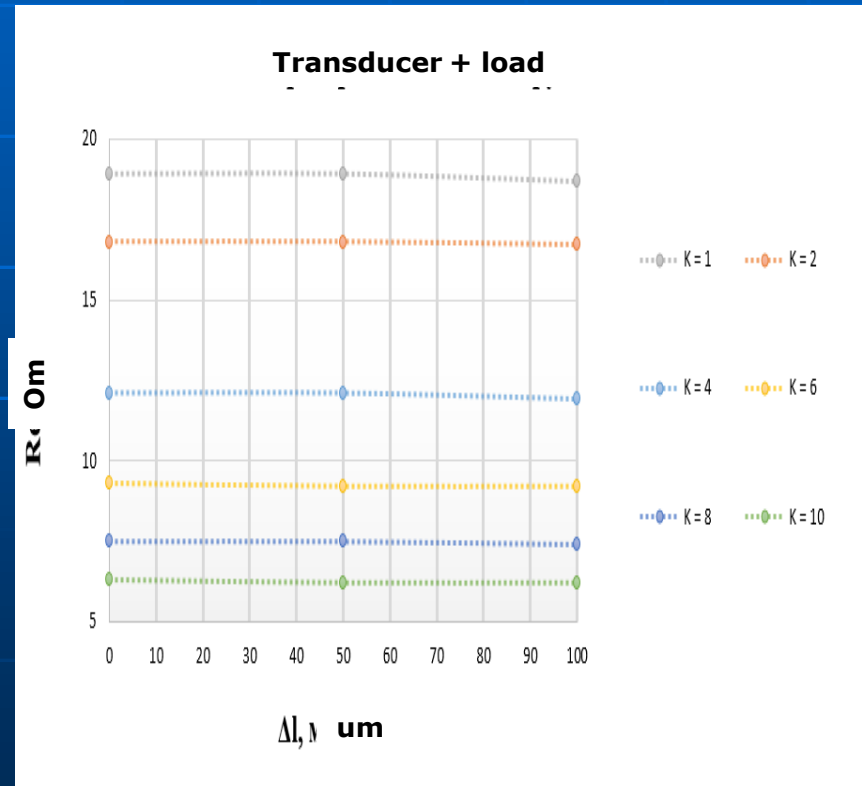


The dependence of resistance on change in propagation conditions for various construction of vibratory system

Full wave resistance



Active resistance

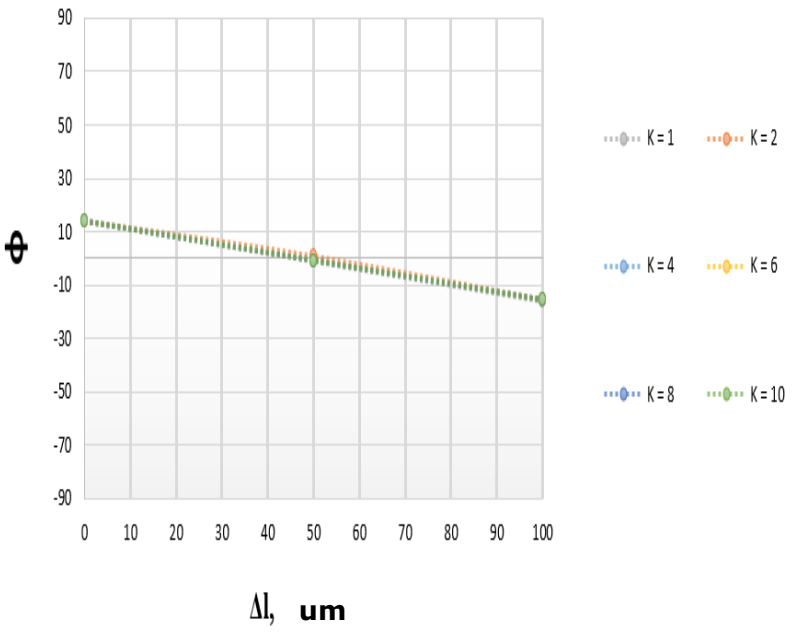


The dependence of phase and reactive resistance on change in propagation conditions for various construction of vibratory system

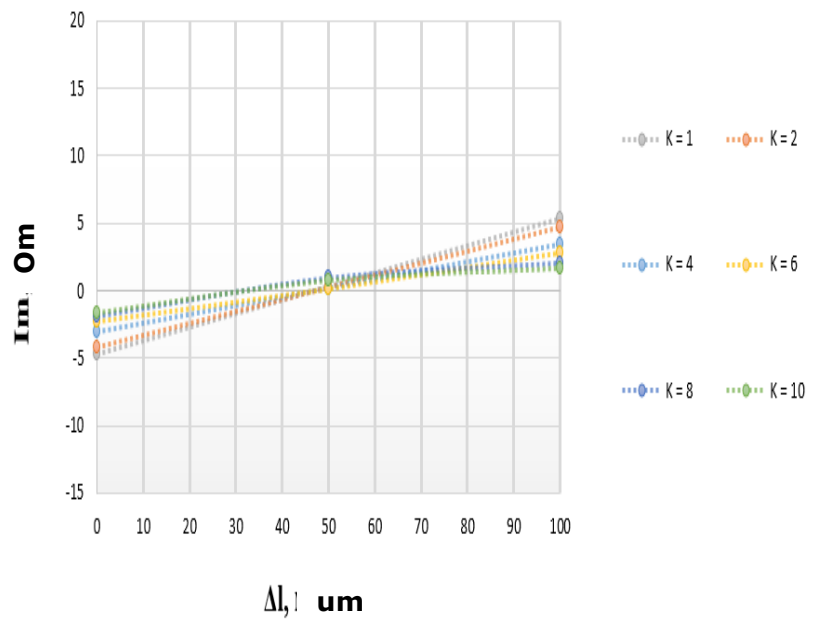
Phase

Reactive resistance

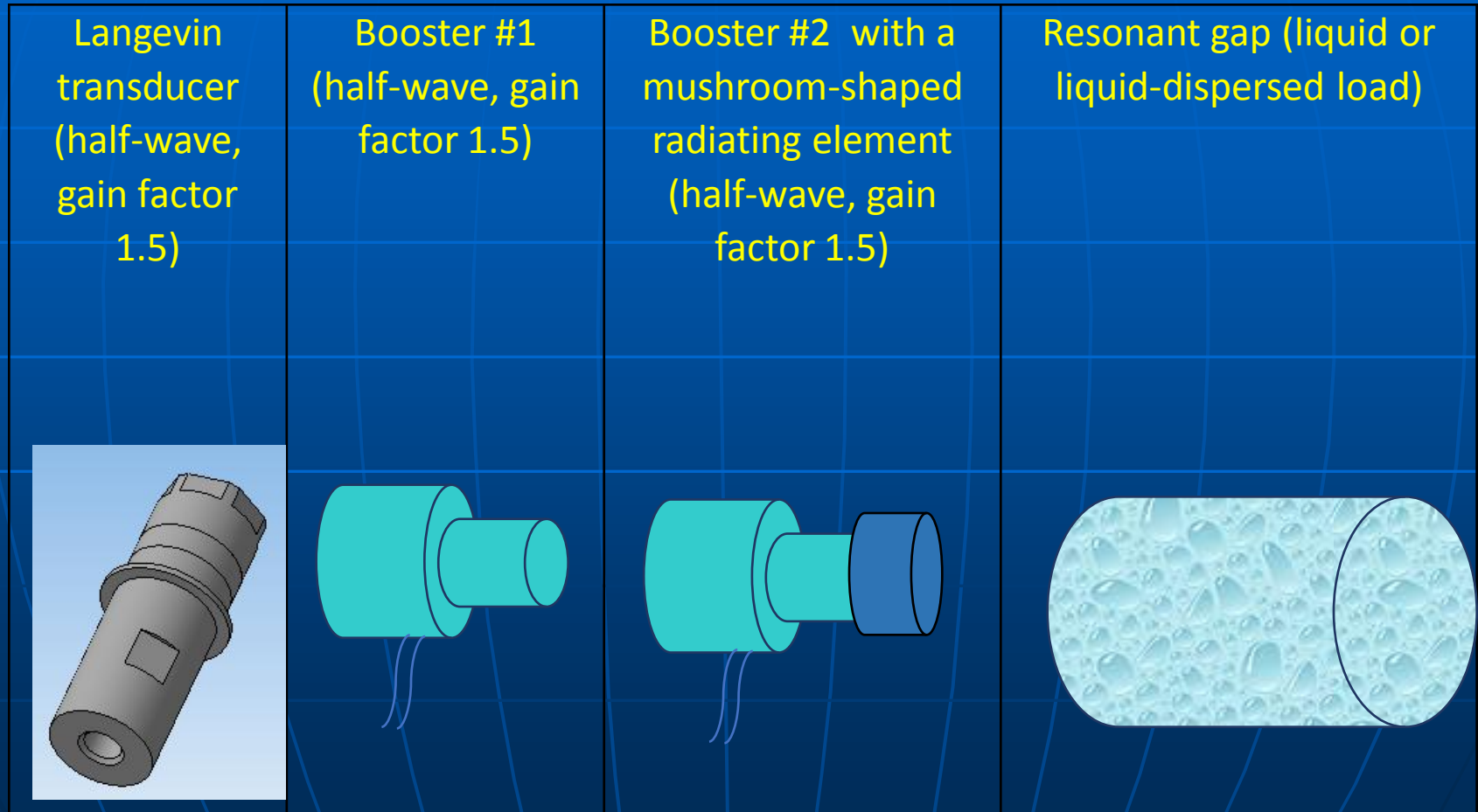
Transducer + load



Transducer + load

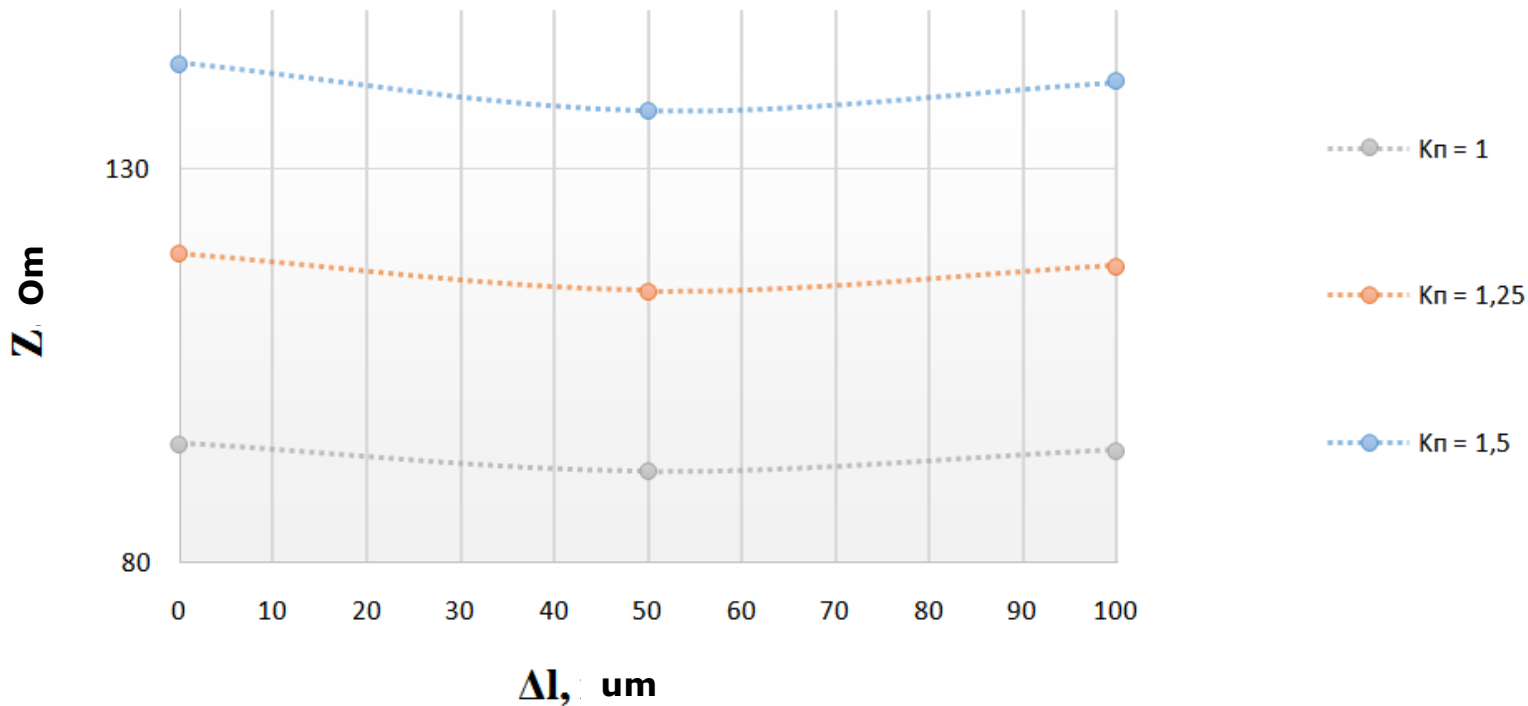


THE SCHEME OF REALIZATION OF PROCESSING BY VIBRATORY SYSTEM WITH A SPECIAL TOOL



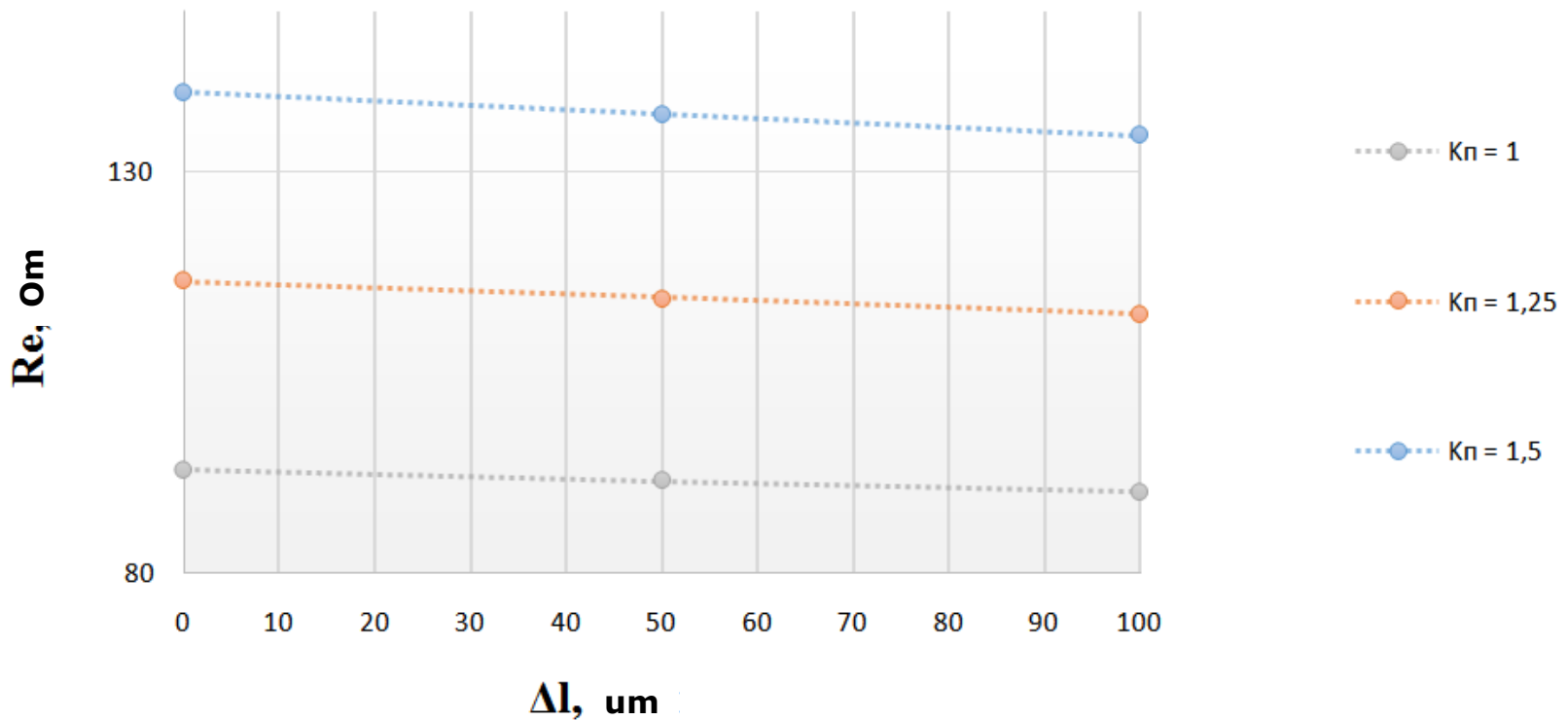
Dependence of the impedance of the ultrasonic radiator for different areas of contact with the medium

Transducer + booster #1 + booster #2 + load (K=1.5)



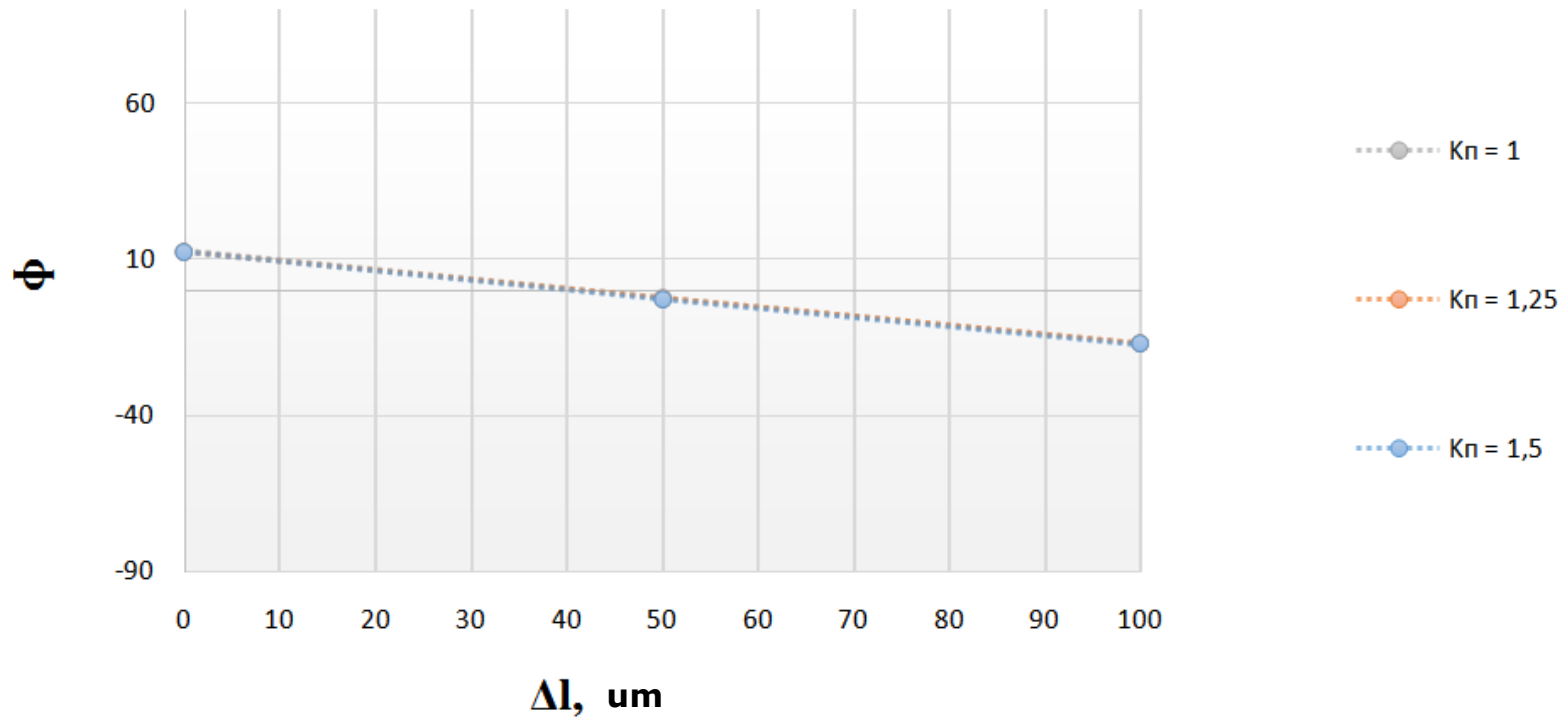
Dependence of the active resistance of the ultrasonic radiator for different areas of contact with the medium

Transducer + booster #1 + booster #2 + load (K=1.5)



Dependence of the reactive resistance of the ultrasonic radiator for different areas of contact with the medium

Transducer + booster #1 + booster #2 + load (K=1.5)



Dependence of the phase of the ultrasonic radiator current for different areas of contact of the radiating surface with the medium

Transducer + booster #1 + booster #2 + load (K=1.5)

